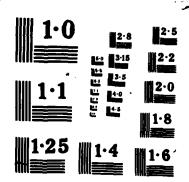
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ELECTRICAL AND THERMAL TRANSPORT PROPERTY STUDIES OF HIGH-TEMPERATURE THERMOELECTRIC MATERIALS: INTERIM TECHNICAL REPORT FOR THE PERIOD MAY 15, 1984 TO MAY 15, 1985

J. L. Bates C. W. Griffin W. J. Weber L. C. Olsen*

June 1985

Prepared for Air Force Office of Scientific Research under AFOSR Contract #F49620-83-C0109



Battelle, Pacific Northwest Laboratories Richland, Washington 99352

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4. TITLE (and Subtitle)	5. TYPE OF REPORT & PERIOD COVERED							
Electrical and Thermal Transport Property Studies	Interim le inical Report for							
of High-Temperature Thermoelectric Materials	Period IS May 34 to 15 May 8							
01 H2gh 12mp014b410 1H61m062566126 12b61425	6. PERFORMING ORG. REPORT NUMBER							
7. AUTHOR(s)	8. CONTRACT OR GRANT NUMBER(2)							
J. L. Bates L. C. Olsen								
W. J. Weber C. W. Griffin	F49620-83-C0109							
9. PERFORMING ORGANIZATION NAME AND ADDRESS	10. PROGRAM ELEMENT, PROJECT, TASK AREA & WORK UNIT NUMBERS							
Battelle, Pacific Northwest Laboratories	2306/AZ							
P.O. Box 999	2306/A2							
Richland, WA 99352	10							
11. CONTROLLING OFFICE NAME AND ADDRESS	12. REPORT DATE							
2011/00 AF2 0109 410	July 1985 13. NUMBER OF PAGES							
AFUSRINE BIRG 410 POILING AFB Wash DC 20332-6448	38							
14. MONITORING AGENCY NAME & ADDRESS(If different from Controlling Office)	15. SECURITY CLASS. (of this report)							
1	INCLAGOUSED							
	15a. DECLASSIFICATION/DOWNGRADING							
	SCHEDULE							
16. DISTRIBUTION STATEMENT (of this Report)								
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17. DISTRIBUTION STATEMENT (of the abetract entered in Block 20, if different from the state of	om Report)							
19. KEY WORDS (Continue on reverse side if necessary and identify by block number) High-Temperature Thermolelectric Materials, Electrical Conductivity, Thermal Conductivity, Seebeck coefficient, Figure of Merit, Chromites, In203-Sn02, In203-Hf02, manganates.								
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Research will continue to emphasize the small polaron thermoelectric model. To verify and refine the model, experimental transport measurement studies will emphasize the effects of substitutions in the ABO, perovskite structure, particularly the distorted lattice developed by substitution on the B or O sites which increases inequivalent sites for hopping of small polarons. As a result of improvements in the thermal diffusivity apparatus, the effect of dopant on thermal conductivity will be investigated. The theoretical and experimental studies will be expanded to include the oxysulfides and sulfides, which should exhibit high electrical conductivity, high Seebeck coefficients, low thermal conductivity and, therefore, high figures of merit.

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1.0 SUMMARY

The research effort during this reporting period has continued to emphasize the study of electronically conducting oxides, which was initiated in the previous reporting period. The high-temperature transport property data base has been expanded by continued measurements in several systems under study, and a theoretical model for thermoelectric properties based on small polaron transport has been developed. The study of the transport properties of the ${\rm In_2O_3-SnO_2}$ system, which was initiated during the previous reporting period, has been completed. Low values for the figure of merit were obtained, as expected, for these degenerate—type semiconductors.

Some high-temperature materials that exhibit small polaron conduction have the potential to exhibit high figures of merit. The theoretical model developed under this program predicts that narrow-band semiconductors with small polaron hopping along inequivalent sites of distorted sublattices can result in increases in both electrical conductivity and Seebeck coefficient with temperature without significant increases in thermal conductivity. High figures of merit, greater than 1.0 at 1000 K, that increase with temperature are predicted by the model. The model is being applied to the divalent metal-doped (Y,La)CrO₃ systems with the ABO₃ perovskite structure. Transport property data obtained during this reporting period for different divalent metal dopants at different concentrations are being used to evaluate the model.

Research will continue to emphasize the small polaron thermoelectric model. To verify and refine the model, experimental transport measurement studies will emphasize the effects of substitutions in the ABO₃ perovskite structure, particularly the distorted lattice developed by substitution on the B or O sites which increases inequivalent sites for hopping of small polarons. As a result of improvements in the thermal diffusivity apparatus, the effect of dopant on thermal conductivity will be investigated. The theoretical and experimental studies will be expanded to include the oxysulfides and sulfides, which should exhibit high electrical conductivity, high Seebeck coefficients, low thermal conductivity and, therefore, high figures of merit.

2.0 INTRODUCTION

The purpose of this report is to describe the technical results obtained during the second year of this continuing research project, covering the period from May 15, 1984 to May 15, 1985. The general objectives of this research investigation are to: a) develop theoretical models for electrical, thermal, and thermoelectric behavior of refractory oxide materials, b) determine electrical transport properties necessary to develop and test these models, c) determine methods for increasing the figure of merit in refractory oxide systems by varying composition, defect structure, microstructure, etc., and d) use these models to establish theoretical and empirical limits of the figure of merit for these oxides and other refractory materials.

During the first year of this project, existing data and theoretical models were extensively reviewed and evaluated. The research emphasized the initial measurements of high-temperature transport properties in the oxide systems based on the $\ln_2 0_3 - \text{Sn} 0_2$, $(\text{La,Y}) (\text{Mg,Ca,Sr}) \text{Cr} 0_3$, $\text{Hf} 0_2 - \text{R}_x 0_y - \ln_2 0_3$, and $\text{La}(\text{Sr}) \text{Mn} 0_3$. This included the development of a novel technique for rapid, high-temperature determination of the absolute Seebeck coefficient. Based on the literature review and evaluation, the theoretical modeling effort concentrated on theories for the figure of merit and the transport properties of both broad-band and narrow-band semiconducting oxides, with particular emphasis on small polaron transport.

The research effort during this second year has continued to emphasize the determination of high-temperature transport property data that was initiated during the first year on several oxide systems. The theoretical modeling has focused on small polaron transport in narrow-band semiconducting oxides and has been applied to the divalent metal-doped (Y,La)CrO₃ system with the ABO₃ perovskite structure. These results, conclusions, and future research are described in the following sections of this report. In addition, the appendices contain tabulated data and the drafts of two papers being prepared for publication.

3.0 TRANSPORT PROPERTY MEASUREMENTS

The transport properties, which include the electrical conductivity, Seebeck coefficient, and thermal conductivity, were measured for the series of materials listed in Table 3.1. These materials include doped yttrium chromites, In203-Sn02, (a) and Zr02-Pr02-In203. (a) Although some chromite (ABO3 perovskite) data were reported last year, the samples discussed in this report contained a wider range of A-site dopants and each sample was given a standardized heat treatment prior to the measurements. The chromite samples discussed in last year's report were not all prepared under standardized conditions, which led to some variation in transport properties.

3.1 MEASUREMENT TECHNIQUES

Generally, the same techniques described in last year's report were used to measure the transport data during this reporting period; however, some improvements were made in apparatus and software. The electrical conductivity was measured using the four-contact DC probe method. The electrical conductivity apparatus was modified to accommodate two samples for simultaneous measurements. Data obtained under identical conditions from two different samples can be readily compared. In addition, twice as many samples can be measured as before. This apparatus is presently being further modified for computer-controlled data acquisition.

The thermal conductivity was calculated from the product of the thermal diffusivity (determined by the flash technique), specific heat (determined by the rule of mixtures), and density. The thermal diffusivity apparatus has been directly interfaced with a computer during this reporting period. The modification allows data storage and preliminary calculation and graphic display of the thermal diffusivity during the series of measurements, which increases cost efficiency by identifying any data deficiencies. Final calculations are carried out after a complete data set is obtained.

⁽a) The fabrication, transport property, and crystallographic studies for these oxides were conducted in part under a U.S. Department of Energy contract by Battelle, Pacific Northwest Laboratories. The data are included because of their significance.

TABLE 3.1. Sample Compositions

Sample Identification	Composition
AF-14	(La _{0.5} , Y _{0.5}) _{0.98} Sr _{0.02} Cr ₀ 3
AF-15	(La _{0.5} , Gd _{0.5}) _{0.98} Sr _{0.02} CrO ₃
AF-16	(Y _{0.5} , Gd _{0.5}) _{0.98} Sr _{0.02} CrO ₃
AF-17	(Y _{0.99} , Ba _{0.01})CrO ₃
AF-18	(Y _{0.98} , Ba _{0.02})CrO ₃
AF-19	(Y _{0.95} , Ba _{0.05})CrO ₃
AF-20	(Y _{0.98} , Sr _{0.02})CrO ₃
AF-21	(Y _{0.95} , Sr _{0.05})CrO ₃
AF-22	(Y _{0.925} , Sr _{0.075})CrO ₃
AF-23	(Y _{0.90} , Sr _{0.10})CrO ₃
AF-24	(Y _{0.85} , Sr _{0.15})CrO ₃
AF-25	(Y _{0.95} , Ca _{0.05})CrO ₃
AF-26	(Y _{0.875} , Ca _{0.125})CrO ₃
AF-27	(Y _{0.85} , Ca _{0.15})CrO ₃
AF-28	(Y _{0.98} , Mg _{0.02})CrO ₃
AF-29	(Y _{0.90} , Mg _{0.10})CrO ₃
AF-30	(Y _{0.85} , Mg _{0.15})CrO ₃
AF-36	(La _{0.84} , Sr _{0.16})Cro ₃
AF~38	(La _{0.84} , Sr _{0.16})(Al _{0.15} , Cr _{0.85})0 ₃
AF-39	$(La_{0.9}, Ca_{0.1})(Al_{0.15}, Cr_{0.85})^{0}$
AF-40	La(Mg _{0.02} , Al _{0.15} , Cr _{0.83})0 ₃
AF-41	La(Mg _{0.02} , Al _{0.15} , Cr _{0.83})0 ₃
AF-42	(La _{0.9} , Ca _{0.1})(Al _{0.15} , Cr _{0.85})0 ₃
FCCP-166	30 mol% PrO ₂ , 70 mol% ZrO ₂
FCCP-54	9.0 mol% In ₂ 0 ₃ , 39.9 mol% Pro ₂ , 51.1 mol% Zro ₂
FCCP-144	75 mol% In ₂ 0 ₃ , 25 mol% Zr0 ₂
FCCP-160	18.2 mol% In ₂ 0 ₃ , 58.7 mol% PrO ₂ , 23.1 mol% ZrO ₂
FCCP-93	20.1 mol% In ₂ 0 ₃ , 39.6 mol% Pro ₂ , 40.3 mol% Zro ₂
FCCP-52	23.0 mo1% In ₂ 0 ₃ , 34.3 mo1% Pro ₂ , 42.7 mo1% Zro ₂
FCCP-51	36.6 mol% In ₂ O ₃ , 28.6 mol% PrO ₂ , 34.8 mol% 2rO ₂

TABLE 3.1. Sample Compositions (Continued)

Sample Identification	Composition
FC-56	11.2 mo1% In ₂ 0 ₃ , 89.8 mo1% SnO ₂
FC-57	16.3 mol% In ₂ O ₃ , 83.7 mol% SnO ₂
FC-59	31 mol% In ₂ 0 ₃ , 69 mol% SnO ₂
FC-125	40 mol% In ₂ O ₃ , 60 mol% SnO ₂
FC-97-7	50 mo1% In ₂ O ₃ , 50 mo1% SnO ₂
FC-126	60 mol% In ₂ O ₃ , 40 mol% SnO ₂
FC-97-9	70 mo1% In ₂ O ₃ , 30 mo1% SnO ₂
FC-97-10	80 mol% In ₂ O ₃ , 20 mol% SnO ₂
FC-160	90.2 mo1% In ₂ 0 ₃ , 9.8 mo1% SnO ₂

The novel apparatus developed on this program at Battelle to measure the Seebeck coefficient has not been changed; however, the computer program has been modified to properly correct for the emf of the Pt lead wires. In last year's report, the emf of the Pt lead wires was incorrectly subtracted from the voltage drop across the sample instead of added. (The data were not recalculated because of deficiencies in material preparation noted above). The apparatus and modified computer program were used to gather data and calculate the Seebeck coefficients of the materials listed in Table 3.1. In addition, the Seebeck coefficient of a Pt rod was determined for reference, and the measured data were within two percent of the data of Laubitz (1969) and Moore and Graves (1973).

The transport data for each property was fitted according to the following equations:

log
$$\sigma = A + B/T$$

log $(\sigma \times T) = A + B/T$
 $\lambda = (A + BT)^{-1}$
 $S = A + BT + CT^2 + DT^3$

where σ is the electrical conductivity, 1/(ohm-cm), λ is the thermal conductivity, W/m-K, S is the Seebeck coefficient, $\mu V/K$, and T is the temperature, K. The coefficients A, B, C, and D (different for each property) were determined by fitting the appropriate equation to the data. The fitted coefficients and calculated transport properties are given in Appendix A for each composition tested. The equations for $\log \sigma$ and and $\log (\sigma T)$ were fitted separately to the electrical conductivity data; consequently, the values for σ determined from

these equations will differ somewhat. The Seebeck coefficient was determined as a function of temperature using a third order polynomial, even though the model in Section 4.2 for small polaron-conducting materials proposes a linear relation-ship. The third order fit of the Seebeck coefficient was used in calculating the figure of merit because it gave the best fit for all data over the wide range of compositions and different conduction mechanisms.

The figure of merit (Z) and dimensionless figure of merit (ZT) were determined from the calculated equations for the transport properties by:

$$z = \frac{s^2}{\lambda}$$

$$z_T = \frac{s^2}{\lambda} * T$$

The figures of merit are given in Appendix A.

3.2 SAMPLE PREPARATION

The ${\rm In_2O_3}$ -SnO₂ samples were prepared at Battelle by pressing and sintering coprecipitated powders. The details of the fabrication procedure are given in Appendix B. The ${\rm ZrO_2}$ -PrO₂-In₂O₃ samples were also fabricated at Battelle from coprecipitated powders using the same procedure.

The chromite samples (AF-14 to AF-30) were prepared by Harlan Anderson at the University of Missouri, Rolla, by pressing and sintering powders prepared by the liquid-mix method of Pechini (1967). Chromite samples AF-36 to AF-42 were obtained from Hugo Schmidt (1981) at Montana State University. These samples were prepared by either General Refractories Company or A-T Research Company. The exact preparation techniques for these samples are unavailable.

All of the chromite samples were heat treated in air at 1500°C for 48 h, followed by an additional 48 h in air at 1550°C. This heat treatment was necessary to fully oxidize the samples, since they were fabricated under reducing conditions.

3.3 RESULTS

The transport property data and calculated figures of merit for the ${\rm In_2^0}_3{\rm -Sn0_2}$, the ${\rm In_2^0}_3{\rm -Pr0_2{\rm -Zr0_2}}$, and the ABO $_3$ perovskite systems are discussed in this section of the report. Additional data are contained in Appendix A.

3.3.1 $\frac{Ir_1}{2} \frac{0}{3} - \frac{Sn0}{2}$

The study of the structure and transport properties of the $In_2O_3-SnO_2$ system was completed and a paper describing the results is attached, Appendix B. These materials were of interest due to their high electrical conductivity, which is greater than 1000 (ohm-cm)⁻¹ for compositions above 70 m/o In_2O_3 . The electrical conductivity increased with the concentration of ${\rm In_20_3}$ and reached a maximum near 80 m/o In,0,. The Seebeck coefficient was negative for all compositions and became more negative as temperature increased. The Seebeck coefficient varied with composition; below 40 m/o In_2O_3 , the Seebeck coefficient was between -50 and -60 μ V/K at 1000 K. From 40 to 80 m/o In₂O₃, the Seebeck coefficient decreased from -100 to -30 $\mu V/K$ with increasing ${\rm In}_2 \theta_3$ concentration. The Seebeck coefficients increased slightly to -60 μ V/K at 90 m/o In₂O₃. As the Seebeck coefficient decreased, the electrical conductivity increased. dimensionless figure of merit (ZT) increased with the In₂O₃ content and reached a maximum of 0.2 for 70 m/o In_2O_3 at 1200 K, as shown in Figure 3.1. The dimensionless figure of merit decreased significantly for the 80 m/o ${\rm In}_2{\rm O}_3$ composition due to an order of magnitude increase in thermal conductivity. The increase in thermal conductivity was probably due to the contribution of the electronic component to thermal conductivity, which was negligible for the other compositions. The small negative Seebeck coefficient indicates that this material

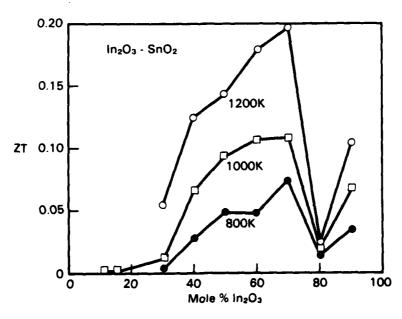


FIGURE 3.1. Dimensionless Figure of Merit (ZT) as a Function of In203 Content

behaves as a degenerate semiconductor. The compositions exhibiting the highest ZT values from 40 to 70 m/o $\ln_2 O_3$ appear to be structurally related to the rhombohedral $\ln_4 \mathrm{Sn}_3 O_{12}$ (40 m/o) composition. A minor noncrystalline phase present in this same composition range may also be affecting the behavior. The minimum values of ZT near 80 m/o $\ln_2 O_3$ are related to the body-centered-cubic (bcc) solid solution limit of SnO_2 in $\ln_2 O_3$.

3.3.2 $\underline{\text{In}_2\text{O}_3\text{-PrO}_2\text{-ZrO}_2}$

Depending on the composition and structure, this system can exhibit high electrical conductivity with negative Seebeck coefficients or low electrical conductivity with high positive Seebeck coefficients, as illustrated in Figures 3.2 and 3.3. The structure of this system consists of a number of phases, the most important being a body-centered-cubic (bcc) $\operatorname{In}_2 O_3$ phase, which brings about the high electrical conductivity. In the absence of the bcc phase, the electrical

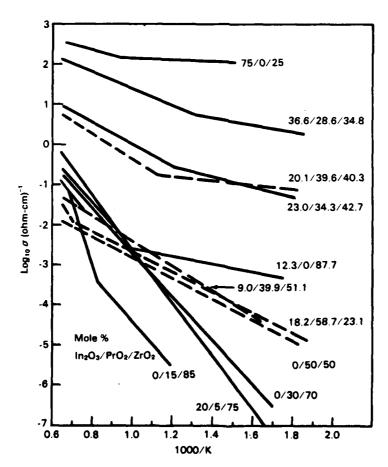


FIGURE 3.2. Electrical Conductivity of In203-PrO2-ZrO2 System

conductivity of this system (primarily a pyrochlore, ${\rm Zr_2Pr_2O_7}$, and orthorhombic ${\rm Pr_2In_2O_7}$) was low with high positive Seebeck coefficients indicating ionic conduction similar to cubic ${\rm ZrO_2}$. The dimensionless figure of merit was less than 0.01 for these ionically conducting compositions. Similar behavior has been observed in the isomorphic structure of ${\rm In_2O_3-PrO_2-HfO_2}$.

Compositions containing the bcc phase had high electrical conductivity with negative Seebeck coefficients between 80 and 120 mV/K that became more negative with increased temperature. As the electrical conductivity increased, the dimensionless figure of merit increased. A maximum value for ZT of 0.18 was calculated at 1300 K for 75 $\ln_2 0_3$ -25 ZrO_2 , as shown in Figure 3.4. All these compositions behave similar to a degenerate semiconductor. Additional information on these materials is given in Appendix A.

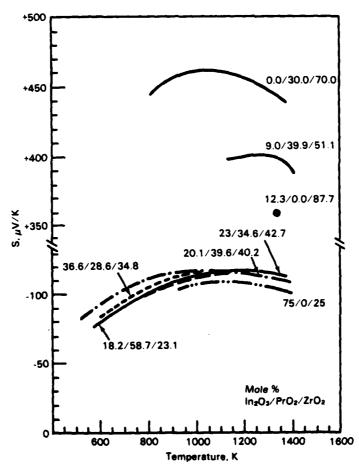


FIGURE 3.3. Seebeck Coefficient for the In203-Pr02-Zr02 System

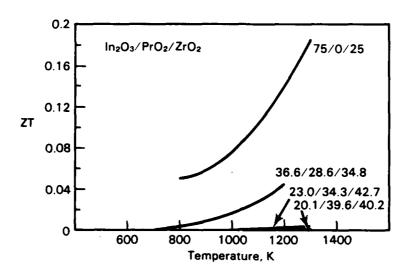


FIGURE 3.4. The Dimensionless Figure of Merit (ZT) for the In₂0₃-Pro₂-Zro₂
System

3.3.3 ABO Perovskites

Electrical conductivity and Seebeck coefficient measurements have been carried out on all the ABO_3 materials received (and heat treated) this year. Thermal diffusivity measurements were delayed because of the upgrade in the apparatus, but are currently being carried out and will be reported in the next interim report. The log (σ T) decreased nearly linearly with inverse temperature and the positive Seebeck coefficient increased nearly linearly with temperature, both in agreement with the model for small polaron transport (discussed later). The maximum values for the figure of merit, ZT, at 1000 K were on the order of 0.015 to 0.020. All of the results are tabulated in Appendix A.

An extensive investigation of the divalent-metal-doped (Y_{1-x}, X_x) CrO₃ series of materials (M = Mg, Ca, Sr, Ba) was carried out during the reporting period. Characterization of the materials by optical and electron microscopy and x-ray diffraction (XRD) indicates that a second phase forms when x = 0.15 and suggests that the solubility limit for the dopants is less than 0.15. Consequently, the data for samples with x = 0.15 are to be viewed with some suspicion due to the unknown effects of the second phase. In addition (as discussed later), a significant fraction of Mg may actually substitute for Cr on the B-site, due to the smaller ionic radius of Mg⁺², which is similar in size to Cr⁺³.

The electrical conductivity, σ , results for (Y M)CrO series of materials are shown in Figure 3.5. The log (σ T) decreased linearly with inverse temperature, in agreement with the theoretical model for small polaron transport (Section 4.2.1). The electrical conductivity generally increased with the amount of dopant and was maximized with Ca as the dopant. The Seebeck coefficient for these same materials increased nearly linearly with temperature, as shown in Figure 3.6, also in agreement with the model (Section 4.2.2). The Seebeck coefficient generally decreased with the amount of dopant and was minimized with Ca as the dopant. The dimensionless figure of merit, ZT, increased with temperature as shown in Figure 3.7, for several of these materials. The largest values of ZT occurred with Ca as the dopant.

The effects of the different dopant species are more clearly indicated in Figures 3.8 and 3.9, where log (σ T), S, and ZT at 1000 K are shown as a function of ionic radius of the dopant. A rather sharp peak (σ , ZT) or valley (S) occurs when Ca is the dopant. This behavior can be attributed to the similar ionic radius of Ca⁺² and Y⁺³, as indicated in Figures 3.4 and 3.5. As the ionic radius of the divalent dopant deviates from that of Y⁺³, more lattice distortion can be expected, with generally detrimental effects. This suggests that maximum performance probably occurs when the ionic radius of any dopant is close to that of the substituted ion. This hypothesis will be explored further in future work and helps to more clearly define the compositions to be studied.

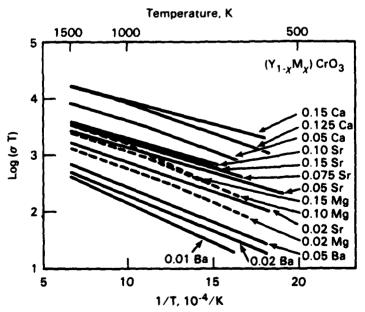


FIGURE 3.5. The Log (σ T) as a Function of Temperature in $(Y_{1-x}^{M})^{Cr0}$ System

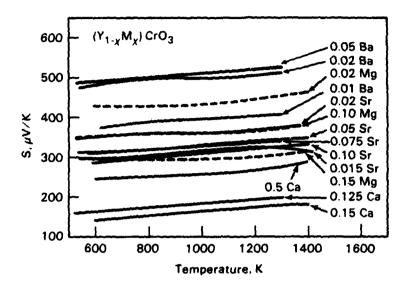


FIGURE 3.6. Seebeck Coefficient as a Function of Temperature in $(Y_1 - M_X)CrO_3$

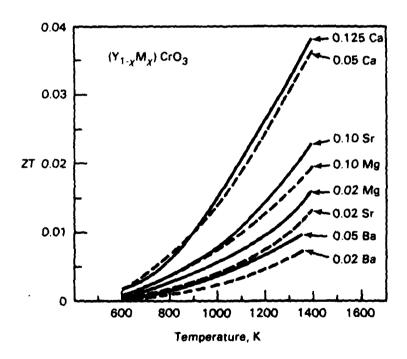


FIGURE 3.7. The Dimensionless Figure of Merit (ZT) as a Function of Temperature in (Y_{1-x} m_x)CrO₃ System

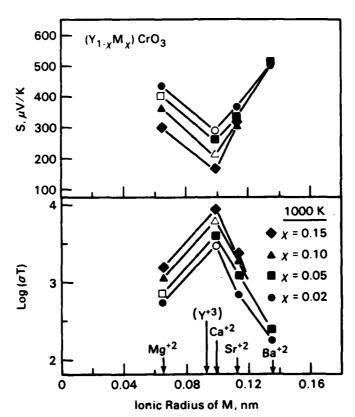


FIGURE 3.8. Log (σT) and S as a Function of Dopant Ionic Radius at 1000 K. Open data points are based on linear interpolation or extrapolation.

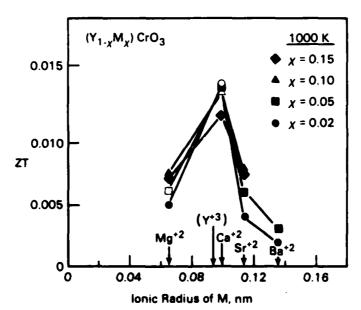


FIGURE 3.9. The Dimensionless Figure of Merit (ZT) as a Function of Dopant Ionic Radius

4.0 THEORETICAL STUDIES

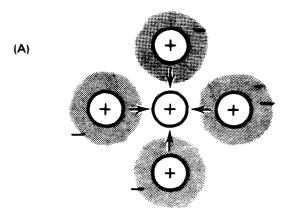
4.1 EVOLUTION OF MODEL

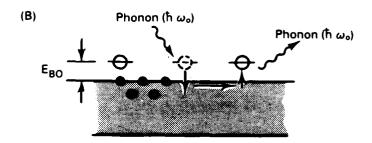
During the first year of this program, several oxide materials were investigated as potential thermoelectric materials. Since oxides typically exhibit small polaron conduction, theoretical studies of small polaron conductors were begun. Initial efforts concentrated on literature review and the development of analytical expressions for thermoelectric properties of small polaron materials. During the current year, a fairly detailed theory for the thermoelectric properties of small polaron materials has been developed. The resulting model is used to carry out calculations of the figure of merit. In addition, the model has been used to interpret experimental data for the $(Y_{1-x}M_{x})CrO_{3}$ perovskites.

In the following sections, the model for small polaron transport is discussed, data for perovskites are interpreted in terms of the developed model, and modeling calculations for ZT are presented.

4.2 MODEL FOR SMALL POLARON TRANSPORT

A small polaron refers to a localized electron state. The electron state is typically localized over a region on the order of a lattice constant. Figure 4.1A presents a rather simple picture of such a state. Each ion is surrounded by an "electron cloud" except the one located at the center, where an orbital electron is missing from the center ion. As a result, the outer electrons of the adjacent ions are attracted toward the center ion, and the energy level of the empty electron state associated with the center ion is increased. The raised energy level is shown in Figure 4.1B as an amount $\mathbf{E}_{\mathbf{RO}}$ above the filled energy band. A "hole" is shown residing in this state. If an electron fills the state, the energy level will be lowered to the top of the energy band. The hole (absence of electron) can move through the lattice. A small polaron is shown hopping between equivalent sites in Figure 4.1B. This process can, of course, be viewed as a normal orbital electron hopping from right to left. Figure 4.1C describes small polarons located at inequivalent sites. As noted in Figures 4.1A and 4.1B, energy is exchanged with the lattice during these hopping processes.





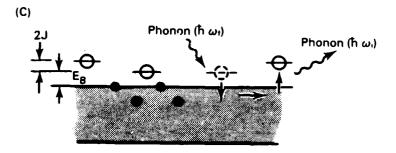


FIGURE 4.1. Schematic Illustration of Polaron Formation (A) and Electron Band Diagram for Small Polarons Located at Equivalent Sites (B) or at Inequivalent Sites (C).

4.2.1 Electrical Conductivity

The electrical conductivity due to small polaron transport is given by

$$\sigma = ne_{\mu}$$
,

where

n = small polaron concentration,

e = electronic charge,

 μ = mobility.

The mobility, μ , is given by

$$\mu = (1-x)(\frac{ea^2v}{e^2}) \exp(\frac{-E}{kT}),$$

where

 $E_a = activation energy$

a = distance between sites

v = optical phonon frequency

x = fraction of sites occupied by small polarons

The activation energy, E_a , is the minimum energy that must be supplied to displace those atoms about the initial and final sites so as to establish a coincident event, that is, to cause the electron energy level at the small polaron site and the electron level at a neighboring site to be coincident. The value of E_a is estimated to be on the order of $E_b/2$, where E_b is the binding energy of the polaron. For hops on the order of 4 Å, the pre-exponential factor in the expression for μ is approximately 1 cm²/V-sec. Thus, small polarons exhibit low values of drift mobility.

The electrical conductivity due to small polaron transport can be fairly large, since the density of carriers can approach the density of atoms in the system. Let N_0 be the density of atoms at which the small polarons may be located, and let x refer to the fraction of these atoms at which small polarons actually exist. The small-polaron density is then given by $n = xN_0$.

4.2.2 Seebeck Coefficient

The Seebeck coefficient (S) is the average energy transferred by a carrier (Peltier heat) divided by eT. S has two terms; one term is related to the location of the Fermi level, that is, the density of carriers. The second term is dependent on the nature of the polaron hopping mechanism. The Seebeck coefficient can be written as

$$S = A + BT$$

where

$$A = (\frac{k}{e}) \ln (\frac{2(1-x)}{x})$$

$$B = (\frac{k}{e}) \frac{z J^2 k}{E_R^3} = (\frac{k}{e}) \frac{z J^2 k}{(E_{RO} - J)^3}$$

and E_B has been estimated to be E_{BO} - J, z is number of nearest available sites for hopping, and J is the overlap integral.

The A-term has always been included in past treatments of small-polaron transport theory. Recent work by Emin and Wood (1983) has led to the addition of the B-term. Thermoelectric studies of boron-carbides revealed that S varied linearly with temperature, and Emin and Wood determined that if hopping occurs between inequivalent sites the B-term results, which can be very significant for some thermoelectric materials. If the B-term is large, the Seebeck coefficient increases dramatically with temperature. Since the figure of merit varies as S^2 , the material can exhibit a significant increase in ZT with temperature.

4.2.3 Possible Values of ZT for Small Polaron Materials

Ure (1972) has calculated potential values of the figure of merit for broad-band materials. He concluded that ZT may approach values on the order of 2 or 3. Heikes and Ure (1961) also examined the potential value of ZT for narrow-band materials. They concluded that ZT for these materials may approach 0.2 or 0.3. However, Heikes and Ure did not account for the B-term in their study. Calculations of ZT for small polaron materials that include the effect of hopping between inequivalent sites are presented in this section.

The following parametric values (typical of perovskites) were assumed in these calculations:

thermal conductivity = 1.0 W/m-K

 $N_o = 7.5 \times 10^{27} \text{m}^{-3}$ $v = 2 \times 10^{13} \text{ Hz}$

 $a_0 = 0.5 \text{ nm}$

 $z = \epsilon$

 $E_{BO} = 0.2 \text{ eV}$

Values of the fraction of sites occupied (x), and the overlap integral (J), were varied to give parametric plots of ZT. The range of these parameters are:

0 < x < 1.0

0 < J < 1.0

Calculations of possible values of S are given as a function of temperature in Figure 4.2, while calculated values of the electrical conductivity versus T are presented in Figure 4.3. These calculated values are combined with the assumed value for thermal conductivity to give ZT versus T in Figure 4.4. It appears that ZT values greater than 1.0 are quite possible for small polaron materials. Two key effects are required: large values of x to give an adequate electrical conductivity and a finite value for J, that is, hopping between inequivalent sites.

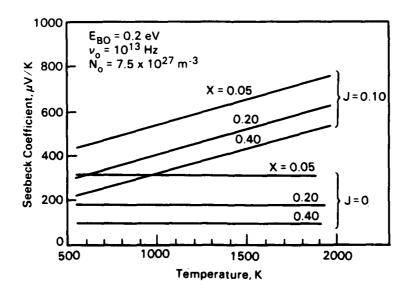


FIGURE 4.2. Theoretically Calculated Seebeck Coefficient as a Function of Temperature

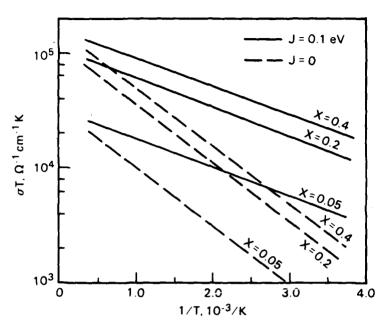


FIGURE 4.3. Theoretically Calculated Values for σT as a Function of 1/T

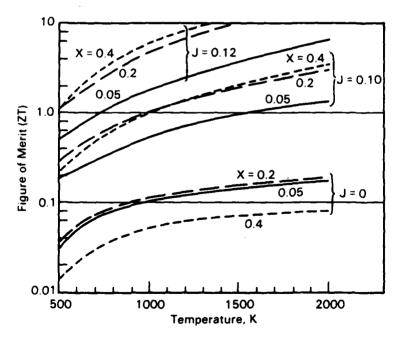


FIGURE 4.4. Theoretically Calculated ZT as a Function of Temperature

4.3 INTERPRETATION OF DATA FOR PEROVSKITES

Several different perovskite materials (ABO₃) were studied this past year. The Y_{1-x} M_x CrO₃ series with M = Mg, Ca, Sr and Ba was investigated in detail. These materials are assumed to have an electron band diagram described by Figure 4.5A. The π -band is a narrow band with a tendency toward localization. Figure 4.5B describes the expected band structure when divalent ions are substituted on the A-lattice. The divalent ion causes a hole to be formed in the π -band. The hole is localized and is thus a small polaron state. The hole is assumed to be in the form of a Cr ⁴⁺ ion.

Electrical conductivity data were acquired for temperatures between 500 K to 1400 K. The electrical conductivity and Seebeck coefficient exhibit temperature dependence consistent with small polaron theory. Thus, σ and S can be expressed by the following relationships:

$$\sigma = \sigma_0 T^{-1} \exp \left(-\frac{E_a}{kT}\right)$$

$$S = A + BT$$

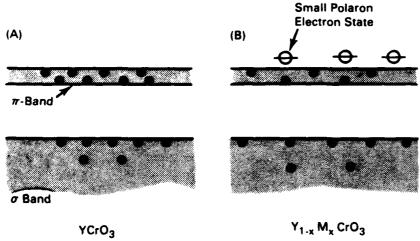


FIGURE 4.5. Electron Band Structure for YCrO₃ (A) and $(Y_{1-x}M_x)CrO_3$ (B)

Transport parameters deduced by interpreting the data for σ and S in terms of the above expressions are tabulated in Table 4.1. Consider the materials for which Ca, Sr and Ba have been substituted on the A site. For a given value of x, the parameter A increases with the ionic radius of the dopant M. Since this term primarily depends on the location of the Fermi level, the actual value of x must be less than the intended value. Figure 4.6 describes the A-values obtained for these materials versus x. The behavior of A for all materials is in qualitative agreement with theory. The material for which the data deviate the most is $Y_{1-x}Ba_xCro_3$. Both A and B increase with x. This behavior is not yet understood. Although the electrical conductivity is relatively low, it is also increasing with x; thus, the $Y_{1-x}Ba_xCro_3$ should be investigated further.

Referring to Figure 4.6, the A and A' are theoretical quantities defined by

$$A = (\frac{K}{e}) \log_e(\frac{2(1-x)}{x})$$

$$A' = (\frac{K}{e}) \log_e(\frac{(1-x)}{x})$$

TABLE 4.1. Transport Parameters for Chromites

Compound	ж	σΤ @ ₁ 1000 ₁ Κ (ohm cm K)	E (e♥)	Α (μV/K)	Β (_μ v/κ ²)	J (eV)
Y _{1-x} Ba _x CrO ₃	0.01	139	0.238	356	0.0394	0.0546
	0.02	190	0.256	460	0.0426	0.0634
	0.05	261	0.251	461	0.0489	0.0659
Y _{1-x} Sr _x Cr0 ₃	0.02	770	0.205	323	0.0427	0.0455
	0.05	1337	0.180	283	0.0474	0.0394
	0.075	1669	0.187	281	0.0459	0.0411
	0.1	1932	0.182	262	0.0498	0.0411
	0.015	1755	0.193	279	0.0319	0.0359
Y _{1-x} Ca _x CrO ₃	0.05	3420	0.208	204	0.0561	0.0532
10% % 3	0.125	7768	0.201	134	0.0449	0.0453
	0.15	8800	0.173	110	0.0530	
Y _{1-x} Mg _x CrO ₃	0.02	542	0.234	370	0.0700	0.0710
1-4 4 3	0.10	1060	0.225	300	0.0569	0.0603
<u></u>	0.15	1354	0.256	276	0.0241	0.0477

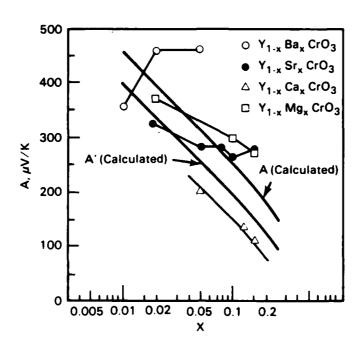


FIGURE 4.6. Experimentally Determined Values for A in (Y_{1-x x})CrO₃ and Theoretical Values for both A and A'

There is no clear indication in Figure 4.6 that one of these forms, A or A', is preferred. Let us assume that A' is correct. Examination of the experimental results versus x indicates that substitution of Ca seems to result in more than one small polaron per Ca atom; while in the other cases, there seems to be less impurity going into the A-site than intended. The results for Ba substitution do not agree with behavior predicted by the model for small polaron transport and are not understood at this time.

Results for the overlap integral, J, are plotted versus x in Figure 4.7. The finite values of J indicate that hopping between inequivalent sites is occurring in these materials. The most significant effect occurs with Mg, which is consistent with the interpretation that some Mg goes onto the B-site.

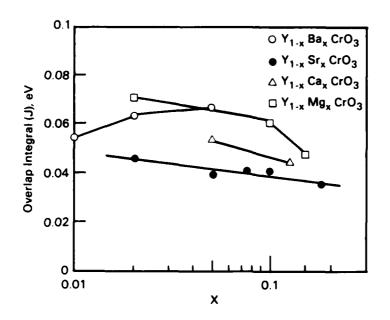


FIGURE 4.7 Experimentally Determined Values of Overlap Integral J in $(Y_x M_x)CrO_3$

Electrical transport properties for these yttrium chromites have been successfully interpreted in terms of small polaron theory. The results suggest some possible approaches for improved (higher) ZT values of the chromites. The addition of small quantities of Mg to the chromites for intended substitution on the A-site results in significant increases of J and, consequently, B. Apparently, a significant fraction of the Mg must substitute for Cr on the B-site. Therefore, improved values of ZT might be achieved by the substitution of Mg for a small fraction of Cr in a highly conducting chromite, such as ${}^{Y}_{0.9}{}^{Ca}_{0.1}{}^{(Cr}_{1-y}{}^{Mg}_{y}{}^{)0}_{3}$.

5.0 FUTURE DIRECTION

Future research will continue to emphasize the small polaron transport model. To verify and refine the model, experimental transport measurements will investigate the effects of substitution in the ABO₃ perovskite structure, particularly substitution on the B or O sites, which should increase the inequivalent sites for hopping of small polarons.

The recent improvements in the thermal diffusivity apparatus will allow an investigation of the effect of dopant (ionic radius) on thermal conductivity and hence ZT. Lattice distortion, such as that discussed in Section 3.3.2, should decrease thermal transport and increase ZT. These measurements have been initiated for the next reporting period.

Next year, studies will be initiated on other material systems, such as the sulfides and oxysulfides. Sulfides are known to exhibit high electrical conductivity but lower thermal conductivity than the chromites (Taher and Gruber, 1981). Initial work will concentrate on sulfur substitution for oxygen in the ABO3 perovskites, since this will allow easy application of the model. Some material preparation work has already been initiated. Eventually, other oxysulfides and sulfides will be investigated with compositions based on model predictions.

6.0 REFERENCES

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APPENDIX A - THERMOELECTRIC PROPERTY DATA

THERMOELECTRIC PROPERTIES

COMPOSITION: (La0.5.y0.5)0.98Sr0.02Cr03

SAMPLE #: AF_14

COMMENTS:

COEFFICIENTS TE									
PROPERTY	UNITS	Α	9	C	D	Ŕz	MINIMUM	MAZIMUM	
log sigma	1/(one-ce)	5.820E-01	3.864E+02			0.790	567	1544	
logisig m axK)	K/(oha-ca)	4.124E+00	7.314E+02			0.999	567	1544	
la s bda	W/(m-K)	2.927E-01	2.355E-04						
S	uV/K	2.105E+02	3.498E-01	-3.400E-04	1.216E-07	0.880	606	1350	

CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(shm-cm)	iambda W/cm-K	S uV/K	7 1/K	21
1	500	-1.90BE-01	2.661E+00	2.436E-02	3.156E+02	2.634E-96	1.317E-03
2	600	-6.203E-02	2.905E+00	2.304E-02	3.243E+02	3.956E-06	2.373E-03
3	700	2.997E-02	3.079E+00	2.186E-02	3.305E+02	5.354E-06	3.748E-03
4	800	9.898E-02	3.210E+00	2.079E-02	3.350E+02	6.781E-96	5.425E-03
5	900	1.525E-01	3.311E+00	1.992E-02	3.386E+02	B. 221E-96	7.399E-03
6	1000	1.956E-01	3.393E+00	1.893E-02	3.419E+02	9.687E-06	9.687E-03
-	1100	2.307E-01	3.459E+00	1.812E-02	3.457E+02	1.122E-05	1.234E-92
8	1200	2.500E-01	3.514E+09	1.738E-92	3.508E+02	1.298E-05	1.546E-92
Ŧ	1300	2.948E-01	3.561E+00	1.570E-02	3.578E+02	1.477E-05	1.920E-02
10	1490	3.060E-01	3.6025+00	1.607E-02	3.675E+02	1.700E-05	1.380E-02

NOTES

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: (La0.5,6d0.5)0.98Sr0.02Cr03

SAMPLE #: AF_15

COMMENTS:

CDEFFICIENTS TEMPERATURE, K										
PROPERTY	UNITS	A	9	C	D	₽2	HINIMUM	MAX [MUM		
	~			~						
log sig ma	1/(ohm-cm)	7.000E-01	3.287E+02		^	0.990	585	1543		
log(sigmaxK)	K/(oha-ca)	4.125E+00	7.261E+02		****	0.999	524	1441		
lambda	W/ (a-K)	2.927E-01	2.355E-04		****			****		
S	uV/K	3.040E+02	4.870E-02	-1.124E-05	8.351E-09	0.910	610	1338		

CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log sig ma	log(sig s axK)	l a s bda	S	1	ZŤ
	K	1/(ohe-ce)	K/(cha-ca)	W/ce-K	uV/K	1/K	
1	500	4. 261E-02	2.673E+00	2.436E-02	3.265E+02	4.828E-06	2.414E-03
2	600	1.522E-01	2.915E+00	2.304E-02	3.309E+02	6.747E-06	4.048E-03
3	700	2.304E-01	3.088E+00	2.186E-02	3.354E+02	8.750E-06	6.125E-03
4	800	2.891E-01	3.217E+00	2.079E-02	3.400E+02	1.082E-05	8.657E-03
5	900	3.348E-01	3.318E+00	1.982E-02	3.448E+02	1.297E-05	1.167E-02
6	1000	3.713E-01	3.399E+00	1.893E-02	3.498E+02	1.519E-05	1.519E-02
7	1100	4.012E-01	3.465E+00	1.812E-02	3.550E+02	1.752E-05	1.927E-02
8	1200	4.261E-01	3.520E+00	1.73 8E- 02	3.606E+02	1.996E-05	2.395E-02
9	1300	4.472E-01	3.566E+00	1.670E-02	3.666E+02	2.254E-05	2.930E-02

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: 'YO.5,6d0.5:0.98Sr0.02Cr03-

SAMPLE #: AF_16

COMMENTS:

	COEFFICIENTS TEMPERATURE, K											
PROPERTY	UNITS	A	В	C	D	8 ₃	MINIMUM	HAXIHUH				

log sigma	1/(ohe-cm)	9.860E-02	9.245E+02			0.990	552	1549				
log(sigmaxK)	K/(ohe-cs)	3.512E+00	1.314E+03			0.999	552	1549				
l a s bda	W/ (m-K)	2.927E-01	2.355E-04									
S	aV/K	5.571E+02	-1.535E-01	1.940E-04	-6.505E-09	0.590	603	1286				

CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/K	Z 1/K	27
i	500	-1.750E+00	8.835E-01	2.436E-02	5.280E+02	2.033E-07	1.016E-04
2	500	-1.442E+00	1.322E+00	2.304E-02	5.334E+02	4.460E-07	2.676E-04
3	700	-1.222E+00	1.634E+00	2.186E-02	5.424E+02	8.072E-07	5.650E-04
4	800	-1.057E+00	1.869E+00	2.079E-02	5.551E+02	1.300E-06	1.040E-03
5	900	-9.287E-01	2.052E+00	1.982E-02	5.713E+02	1.941E-06	1.747E-03
6	1900	-8.259E-01	2.198E+00	1.893E-02	5.911E+02	2.755E-06	2.755E-03
7	1100	-7.419E-01	2.317E+00	1.812E-02	6.143E+02	3.772E-06	4.149E-03
3	1200	-6.718E-01	2.417E+00	1.738E-02	6.410E+02	5.032E-06	6.038E-03
9	1590	-6.125E-01	2.501E+00	1.670E-02	6.711E+02	5.581E-06	8.555E-03

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: (YO.99, Bag. OI) Cr03

SAMPLE #: AF_17

COMMENTS:

			COEFFIC	IENTS			TEMPERA	TURE, K
PROPERTY	UNITS	Α	B	C	D	Ks.	MINIMUM	MAXIMUM
les siess	1//ahaah	1.500E-01	1 0215401			4 9 94	(34	1517
log sigma	1/(oha-ca)	1.3006-01	1.021E+03			0.990	624	1512
log(sigmaxK)	K/(oha-ca)	3.575E+00	1.429E+03	~~~		0.990	624	1512
lambda	W/(a-K)	2.927E-01	2.355E-04		****			
S	uV/K	1.06BE+02	B. 027E-01	-7.635E-04	2.501E-07	0.950	784	1312

CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/K	Z 1/K	21
1	700	-1.309E+00	1.534E+00	2.186E-02	3.804E+02	3.252E-07	2.276E-04
2	800	-1.126E+00	1.789E+00	2.079E-02	3.884E+02	5.425E-07	4.340E-04
3	900	-9.846E-01	1.987E+00	1.982E-02	3.931E+02	8.082E-07	7.273E-04
4	1000	-8.711E-01	2.146E+00	1.893E-02	3.961E+02	1.115E-06	1.115E-03
5	1100	-7.783E-01	2.276E+00	1.812E-02	3.989E+02	1.462E-06	1.609E-03
6	1200	-7.009E-01	2.384E+00	1.738E-02	4.02BE+02	1.85BE-06	2.230E-03
7	1300	-6.355E-01	2.476E+00	1.670E-02	4.095E+02	2.324E-06	3.022E-03

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: (YO. 98, Bao. 02) Cr03

SAMPLE #: AF_18

COMMENTS:

	COEFFICIENTS TEMPERATURE, K										
PROPERTY	UNITS	A	B	C	D	R2	MUMINIM	MAXIMUM			

log sigma	1/(ohe-ce)	1.500E-01	8.930E+02			0.990	569	1552			
log(sigmaxK)	K/(oha-ca)	3.570E+00	1.290E+03			0.9 99	569	1552			
l ambda	W/(a-K)	2.927E-01	2.355E-04								
S	uV/K	2.824E+02	6.152E-01	-5.971E-04	2.020E-07	0.690	590	1320			

CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/K	Z 1/K	27
					~~~~~~~		
1	500	-1.636E+00	9.891E-01	2.436E-02	4.660E+02	2.060E-07	1.030E-04
2	600	-1.338E+00	1.419E+00	2.304E-02	4.802E+02	4.591E-07	2.755E-04
3	700	-1.126E+00	1.727E+00	2.186E-02	4.897E+02	8.214E-07	5.750E-04
4	800	-9.663E-01	1.957E+00	2.079E-02	4.958E+02	1.278E-06	1.023E-03
5	900	-8.423E-01	2.136E+00	1.982E-02	4.997E+02	1.812E-96	1.631E-03
6	1000	-7.430E-01	2.280E+00	1.893E-02	5.025E+02	2.410E-06	2.410E-03
7	1100	-6.618E-01	2.397E+00	1.812E-02	5.055E+02	3.071E-06	3.378E-03
8	1200	-5.942E-01	2.495E+00	1.738E-02	5.099E+02	3.807E-06	4.568E-03
9	1300	-5.369E-01	2.577E+00	1.670E-02	5.168E+02	4.546E-06	6.040E-03

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: (YO.95, BaO.05)CrO3

SAMPLE 4: AF_19

COMMENTS:

			COEFFIC	IENTS			TEMPERA	TURE. K	
PROPERTY	UNITS	A	B	C	Ď	R2	HINIHUH	MAXIMUM	
log sigma	1/(ohm-cm)	2.800E-01	8.747E+02	****		0.990	571	1556	
log(sigmaxK)	K/(ohe-ce)	3.701E+00	1.273E+03			0.999	571	1556	
lambda	W/ (m-K)	2.927E-01	2.355E-04				***		
S	uV/K	4.752E+02	-8.100E-03	7.392E-05	-2.958E-08	0.760	601	1333	

### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log sigma	log(sigmaxK)	l ambda	S	2	ĮΤ
	K	1/(ohm-cm)	K/(ohn-cm)	W/ca-K	uV/K	1/K	
1	500	-1.469E+00	1.154E+00	2.436E-02	4.859E+02	3.288E-07	1.644E-04
2	600	-1.178E+00	1.579E+00	2.304E-02	4.906E+02	6.934E-07	4.161E-04
3	700	-9.696E-01	1.882E+00	2.186E-02	4.956E+02	1.205E-06	8.437E-04
4	800	-8.134E-01	2.109E+00	2.079E-02	5.009E+02	1.855E-06	1.484E-03
5	900	-6.919E-01	2.286E+00	1.982E-02	5.062E+02	2.629E-06	2.366E-03
6	1000	-5.947E-01	2.428E+00	1.893E-02	5.114E+02	3.513E-06	3.513E-03
7	1100	-5.152E-01	2.543E+00	1.812E-02	5.164E+02	4.492E-06	4.941E-03
8	1200	-4.489E-01	2.640E+00	1.738E-02	5.208E+02	5.550E-06	6.660E-03
9	1300	-3.929E-01	2.722E+00	1.670E-02	5.246E+02	6.670E-06	8.671E-03

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: (YO.98,Sr0.02)Cr03

SAMPLE #: AF_20

COMMENTS:

	COEFFICIENTS TEMPERATURE, K									
PROPERTY	UNITS	A	В	C	ũ.	Ą≥	MINIMUM	MAXIMUM		
log sig <b>ma</b>	1/(ohm-cm)	8.870E-01	7.964E+02			0.990	468	1517		
log(sigmaxK)	K/(oha-ca)	4.269E+00	1.149E+03			0.990	468	1517		
lambda	W/ (m-K)	1.355E-01	3.119E-04							
S	uV/K	2.795E+02	2.150E-01	-2.067E-04	7.689E-08	9.830	627	1518		

### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log sigma	log(sigmaxK)	lambda	S	2	ZT
	K	1/(ohm-cm)	K/(ohm-cm)	W/cm-K	uV/K	1/K	
					*		
1	500	-7.059E-01	1.971E+00	3.431E-02	3.449E+02	6.825E-07	3.412E-04
2	600	4 404E-01	2.354E+00	3.099E-02	3.507E+02	1.439E-06	8.635E-04
3	700	-2.508E-01	2.628E+00	2.826E-02	3.550E+02	2.504E-06	1.753E-03
4	800	-1.085E-01	2.833E+00	2.597E-02	3.585E+02	3.855E-06	3.084E-03
5	900	2.078E-03	2.992E+00	2.403E-02	3.616E+02	5.468E-06	4.921E-03
5	1000	9.057E-02	3.120E+00	2.235E-02	3.646E+02	7.328E-06	7.328E-03
7	1100	1.630E-01	3.224E+00	2.089E-02	3.682E+02	9.442E-06	1.039E-02
8	1200	2.233E-01	3.312E+00	1.962E-02	3.727E+02	1.184E-05	1.421E-02
9	1300	2.744E-01	3.385E+00	1.849E-02	3.786E+02	1.458E-05	1.896E-02
10	1400	3.181E-01	3.448E+00	1.748E-02	3.863E+02	1.776E-05	2.487E-02

¹⁾ Thermal conductivity data was estimated.

13MP981713N: .x0.95.3r0.05/Cr03

SAMPLE 4: AF_21

COMMENTS:

COEFFICIENTS										
PPOPERTY	UNITS	A	9	C	0	<b>63</b>	MINIMUM	MAXIMUM		
					**********			*		
log sigma	1/(ohs-cs)	6.300E-01	5.300E+02			0.960	521	1557		
log(sigmaxK)	K/(ohs-cs)	4.033E+00	9.067E+02			0.990	521	1557		
lambda	₩/(m-K)	2.348E-01	2.827E-04			9.224	517	1411		
S	uV/K	3.412E+02	-1.310E-01	1.790E-04	-5.824E-08	9.860	517	1389		

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature #	log sigma 1/kohm-cm)	log(sigmaxK) K/+ohm-cm)	lambda #/cm-K	S uV/K	Z 1/k	27
1	500	-4.300E-01	2.220E+00	2.559E-02	3.131E+02	1.370E-96	5.852E-94
2	á00	-2.533E-01	2.522E+00	2.473E-02	3.144E+02	2.231E-06	1.339E-03
3	790	-1.271E-01	2.738E+00	2.311E-02	3.172E+02	3.249E-06	1.274E-03
4	800	-3.249E-02	2.900E+00	2.170E-02	3.211E+02	4.410E-06	J.52 <b>8E</b> -03
5	900	4.112E-02	3.926E+00	2.044E-02	3.258E+02	5.708E-06	5.138E-03
٥	1990	1.000E-01	3.126F*00	1.933E-02	3.309E+01	7.135 <b>E</b> -06	7.13 <b>5E</b> -03
7	1100	1.482E-01	3.209E+00	1.832E-02	3.361E+02	3.674E-06	7.541E-v3
8	1200	1.883E-91	3.277E+00	1.742E-02	3.411E+02	1.030E-05	1.23aE-02
9	1750	2.223E-01	7.336E+00	1.650E-02	3.454E+02	1.1996-05	1.559E-32
10	1400	2.514E-01	3.385E+00	1.5868-02	3.488E+02	1.Ja9E-05	1.91 <b>6E</b> -0I

| SIMPOSITION: (Y0.925Sr0.075/Er03

SAMPLE #: AF_22

COMMENTS:

SOEFFICIENTS TEMPERATURE										
PROPERTY	UNITS	A	3	C	O	Ķ2	MINIMUM	MAKIMUM		
log sig <b>e</b> a	1/(che-ca)	7.250E-01	5.23 <b>6E</b> +02			0.990	508	1555		
log(sigmaxk)	K/(ohm-cm)	4.165E+00	7.408E+02			0.990	508	1556		
lambda	w/(a-K)	1.355E-01	3.119E-04							
S	u√/k	3.721E+02	-2.090E-01	2.329E-04	-6.951E-08	0.880	757	1475		

### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature #	log sigma 1/(ohm-cm)	log(sigmaxk) K/(onm-cm)	lambda W/cm-K	S uV/K	Z 1/K	21
	300	2 2005 42	7.0345.04	3.60/6.40	7.4.45.00	7 7000 44	2.7476.37
ı	700	-2.29 <b>9E</b> -02	2.821E+00	2.926E-02	3.161E+02	3.352E-06	2.347E-03
2	800	7.051E-02	2.9 <b>8</b> 9E+00	2.597E-02	3.184E+02	4.590E-06	3. <b>6</b> 72 <b>E</b> -03
7	900	1.432E-01	3.120E+00	2.403E-02	3.220E+02	5.000E-06	5.400E-03
4	1000	2.014E-01	3.224E+00	2.235E-02	3.265E+02	7.582E-06	7.582E-03
5	1100	2.490E-01	3.310E+00	2.089E-02	3.315E+02	9.330E-06	1.025E-92
Ď	1200	2.887E-01	3.381E+00	1.962E-02	3.365E+02	1.122E-05	1.347E-92
7	1700	3.222E-01	3.441E+00	1.3498-02	3.413E+02	1.323E-05	1.720E-02
8	1400	3.510E-01	3.493E+00	1.748E-02	3.452E+02	1.530E-05	2.142E-v2
Ģ	1500	3.759E-01	3.53 <b>8E</b> +00	1.657E-02	3.480E+02	1.737E-05	2.605E-92

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: (YO.90Se0.10)Cr03

SAMPLE #: AF_23

COMMENTS:

COEFFICIENTS TEMP										
PROPERTY	UNITS	A	B	C	D	Κs	MUMINIM	MUMIKAN		
*******							******			
log sigma	1/(ohm-cm)	7.650E-01	4.938E+02			0.990	663	1523		
log(sigmaxK)	K/(ohe-ce)	4.203E+00	9.157E+02			0.990	563	1523		
lambda	₩/ ( <b>n</b> -K)	1.355E-01	3.119E-04			0.990	500	1550		
S	an/K	2.191E+02	1.580E-01	-9.842E-05	3.104E-08	0.920	507	1474		

# CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/K	Z 1/K	27
1	500	-5.903E-02	2.677E+90	3.099E-02	2.852E+02	2,296E-06	1.378E-03
÷	700	5.955E-02	2.895E+90	2.826E-02	2.921E+02	3.464E-96	2,425E-03
J	800	1.477E-01	3.058E+00	2.597E-02	2.984E+02	4.818E-06	3.855E-03
4	300	2.163E-01	3.186E+00	2.403E-02	3.042E+02	6.339E-06	5.705E-03
5	1000	2.712E-01	3.287E+00	2.235E-02	3.097E+02	8.015E-06	8.015E-03
Ó	1100	3.161E-01	3.371E+00	2.089E-02	3.152E+02	9.842E-06	1.083E-02
7	1269	3.535E-01	3.440E+00	1.962E-92	3.206E+02	1.183E-05	1.419E-02
3	1300	3.851E-01	3.499E+00	1.949E-02	3.264E+02	1.399E-05	1.819E-02
9	1400	4.123E-01	3.549E+00	1.748E-02	3.326E+02	1.635E-05	2.290E-02
19	1500	4.358E-01	3.593E+00	1.657E-02	3.394E+02	1.896E-05	2.844E-02

COMPOSITION: (YO.85,Sr0.15)Cr03

SAMPLE 4: AF_24

COMMENTS:

			COEFFIC	IENTS			TEMPERA	TURE, K
PROPERTY	UNITS	A	В	C	D	Ŕ²	MINIMUM	MAXIMUM
			*********				******	
log sig <b>ma</b>	1/(ohe-ce)	8.010E-01	5.656E+02			Ú.990	647	1521
iog(sigmaxK)	K/(ohe-ce)	4.235E+00	9.829E+02			0.990	647	1521
lambda	W/(m-K)	1.355E-01	3.119E-04					
S	uV/K	4.497E+02	-5.740E-01	6.790E-04	-2.409E-07	0.870	604	1411

# CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma [/{ohm-cm}	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/K	Z 1/K	21
1	500	-3.302E-01	2.269E+00	3.431E-02	3.024E+02	1.246E-06	6.229E-04
2	500	-1.417E-01	2.597E+00	3.099E-02	2.978E+02	2.064E-06	1.238E-03
3	700	-7.034E-03	2.831E+00	2.826E-02	2.980E+02	3.092E-06	2.165E-03
4	800	9.397E-02	3.006E+00	2.597E-02	3.018E+02	4.353E-06	3.482E-03
5	900	1.725E-01	3.143E+00	2.403E-02	3.075E+02	5.856E-06	5.270E-03
6	1000	2.354E-01	3.252E+00	2.235E-02	3.138E+02	7.577E-06	7.577E-03
7	1100	2.868E-01	3.341E+00	2.089E-02	3.193E+02	9.444E-06	1.039E-02
8	1200	3.296E-01	3.416E+00	1.962E-02	3.224E+02	1.132E-05	1.359E-02
9	1300	3.659E-01	3.479E+00	1.849E-02	3.218E+02	1.301E-05	1.691E-02

i) Thermal conductivity data was estimated.

| COMPOSITION: | (0.95.Ca0.05/Cr03

SAMPLE #: AF_25

COMMENTS:

	TEMPERA	TEMPERATURE. *						
PROPERTY	UNITS	A	В	C	D	Кs	HUNINUM	MAXIMUM
log sigma	1/tohe-cs/	1.376E+00	7.582E+02			0.996	657	992
		9.820E-01	3.696E+02			0.989	992	1543
log(sigmaxK)	K/(cha-ca)	4.720E+00	1.106E+03			0.999	657	992
		4.506E+00	8.984E+02			0.999	992	1540
lambda	₩/ ( <b>a-k</b> )	2.927E-01	2.355E-94					
S	uV/K	1.687E+02	2.184E-01	-2.137E-04	8.457E-08	0.955	564	1504

## CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1'(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S u∜/k	Z 17K	21
:	600	1.1236-01	2.877E+00	2.304E-02	2.411E+02	3.266E-06	1.969E-93
2	709	2.928E-01	3.140E+00	2.186E-02	2.459E+02	5.428E-96	3.79 <b>9E</b> -03
5	800	4.282E-01	3.338E+00	2.079E-02	2.499E+02	9.056E-06	6.444E-03
4	900	5,714E-01	3.508E+00	1.582E-02	2.538E+02	1.211E-05	1.090E-02
5	1000	6.124E-01	3.608E+00	1.893E-02	2.580E+02	1.440E-05	1.440E-02
5	1190	6.460E-01	3.589E+00	1.812E-02	2.629E+02	1.669E-05	1.857E-92
7	1200	5,7498-91	3.757E+00	1.738E-02	2.692E+92	1.968E-05	2.3a1E-02
3	1360	5.977E-01	3.815E+00	1.670E-02	2.772E+02	2.295E-05	2.983E-01
Ç	14.0	7.1808-01	3.864E+00	1.607E-02	2.977E+02	2.a90E-05	3.756E-02
19	15v0	7.356E-01	3.907E+00	1.548E~02	3.00 <b>9E</b> +02	3.181E-05	4.772E-02

¹¹ Thermal conductivity data was estimated.

COMPOSITION: (Y0.875.Ca0.125)Cr03

SAMPLE #: AF_26

COMMENTS:

COEFFICIENTS TEMPER										
PROPERTY	UNITS	A	8	C	D	ŃΣ	MINIMUM	MUMIXAN		
log sigma	1-10hm-cm)	1.580E+00	6.838E+02			0.984	643	1179		
		1.199E+00	2.331E+02			0.862	1179	1520		
log(sigmaxK)	K/(ohm-cm)	4.956E+00	1.055E+03			0.992	643	1179		
• •		4.760E+00	3.123E+02			0.9 <del>9</del> 2	1179	1520		
lambda	w/ (m-K)	4.219E-01	2.120E-04			0.976	547	1407		
S	uV/K	8.480E+01	2.107E-01	-1.648E-04	5.368E-08	0.990	502	1541		

### CALCULHIED THERMOELECTRIC PROPERTIES

	Temperature F	log sigma 1/cons-ce)	log(sigmaxK) K/ioha-cm)	lambda W/cm-k	S uV/k	7 1/K	21
1	590	2.124E-01	2.846E+00	1.894E-02	1.557E+02	2.986E-96	1.043E-03
2	ούô	4.403E-01	3.198E+00	1.821E-02	1.635E+02	4.045E-06	2.427E-03
7	700	6.031E-01	3.449E+00	1.754E-02	1.699E+02	6.a05E-06	4.623E-03
4	800	7.253E-01	3.637E-00	1.691E-02	1.754E+02	9.663E-06	7.730E-03
5	<b>300</b>	8.202E-01	3.784E+00	1.632E-02	1.801E+02	1.313E-05	1.1825-02
5	1000	8.962E-01	3.901E+00	1.578E-02	1,844E+02	1.697E-05	1.697E-02
7	1100	9.871E-01	4.022E+00	1.527E-02	1.886E+92	2.262E-05	2.488E-02
8	1200	1.005E+00	4.083E+00	1.479E-02	1.931E+02	2.549E-05	3.059E-02
ą	1000	1.0206+00	4.135E+00	1.434E-02	1.981E+02	2.365E-)5	3.124E-02

| SOMPOSITION: (10.85,8a0.15)Cr03

SAMPLE #: AF_27

COMMENTS:

	COEFFICIENTS TEMPERATURE, K										
PROPERTY	UNITS	A	В	C	D	8s	MINIMUM	MAXIMUM			
log sigma	1/(ohs-cm)	1.401E+00	4.605E+02			0.999	736	1183			
		1.258E+00	2.914E+02			0.997	1183	1550			
log(sigmaxK)	K/(ohm-cm)	4.758E+00	8.221E+02			0.999	557	1183			
		4.815E+00	8.453E+02			0.999	1193	1550			
lamoda	W/ (m-K)	1.693E-01	8.576E-94			0.904	543	1401			
S	uV/K	7.89 <b>4E</b> +01	1.439E-01	-8.630E-05	2.636E-08	0.986	626	1458			

# CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log sig <b>ea</b>	log(sigmaxK)	l a <b>s</b> bda	S .	1	21
	Κ	1/(che-ce)	K/(ohm-cm)	W/ca-K	ùŸ/K	1/K	
1	500	a.335E-01	3.398E+00	1.462E-02	1.399E+02	5.757E-06	3.454E-03
2	700	7.432E-01	3.594E+00	1.299E-92	1.464E+02	9.135E-06	6.394E-03
3	900	8.254E-01	3.740E+00	1.149E-02	1.523E+02	1.32 <b>8E</b> -05	1.062E-02
4	790	9.893E-01	3.855E+00	1.062E-00	1.57SE+02	1.916E-05	1.634E-02
5	1000	9.405E-01	3.946E+00	9.739E-03	1.629E+02	2.376E-05	2.376E-02
5	1100	9.931E-01	4.028E+00	8.987E-03	1.679E+02	3.087E-05	3.396E-02
7	1200	1.015E+00	4.094E+00	8.344E-03	1.729E+02	3.710E-05	4.452E-02
8	1700	1.034E+00	4.149E+00	7.787E-03	1.781E+02	4.403E-05	5.724E-02
ą	1400	1.050E+00	4.197E+00	7.299E-03	1.836E+92	5.179E-05	7.251E-02

COMPOSITION: (Y0.98.Mg0.02)Cr03

SAMPLE #: AF_28

COMMENTS:

COEFFICIENTS									
PROPERTY	UNITS	A	9	C	ם	<b>8</b> 3	HINIHUH	HUNIXAR	
log sigma	1/(ohm-cm)	7.400E-01	9.516E+02			0.996	607	875	
		3.500E-01	6.046E+92			0.999	875	1547	
log(sigmaxK)	K/ (oha-ca)	4.037E+00	1.264E+03			0.997	607	875	
		3.857E+00	1.108E+03			0.998	875	1547	
lambda	W/(m-K)	2.927E-01	2.355E-04						
S	uV/K	4.925E+02	-1.900E-01	1.555E-04	-2.374E-08	0.972	749	1516	

### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/k	Z 1/K	ZT
			*********				
I	600	-8.459E-01	1.930E+00	2.304E-02	4.293E+02	1.140E-06	5.843E-04
2	70 <b>0</b>	-6.19 <b>4E-</b> 01	2.231E+00	2.186E-02	4.275E+02	2.009E-06	1.405E-03
3	800	-4.057E-01	2.472E+00	2.079E-02	4.278E+02	3.460E-06	2.768E-03
4	900	-3.217E-01	2.626E+00	1.982E-02	4.301E+02	4.450E-06	4.005E-03
5	1990	-2.546E-01	2.749E+00	1.893E-02	4.342E+02	5.5416-06	5.541E-03
6	1100	-1.996E-01	2.850E+00	1.812E-02	4.400E+02	6.746E-06	7.421E-03
7	1200	-1.538E-01	2.934E+00	1.738E-02	4.474E+02	8.079E-06	9.695E-03
В	1300	-1.151E-01	3.005E+00	1.670E-02	4.561E+02	9.558E-06	1.243E-02
9	1400	-8.184E-02	3.066 <b>E+00</b>	1.607E-02	4.561E+92	1.120E-05	1.568E-02
10	1500	-5.305E-02	3.118E+00	1.548E-02	4.772E+02	1.302E-05	1.953E-02

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: (YO.90,Mg0.10)Cr93

SAMPLE #: AF_29

COMMENTS:

			COEFF 10	CIENTS			TEMPERA	TURE. K
PROPERTY	UNITS	A	8	c	D	₽2	MINIMUM	MAXIMUM
						*=**	~~~~~	
log sigma	1/(ohm-cm)	9.670E-01	8.977E+02			0.992	609	987
		5.400E-01	4,913E+02			0.997	987	1549
log(sigmaxK	) K/(ohm-cm)	4.291E+00	1.229E+03			0.998	409	987
•		4.064E+00	1.019E+03			0.999	987	1549
l ambda	W/ (m-K)	2.927E-01	2.355E 04		****			
S	uV/K	2.980E+02	1.910E-01	-2.203E-04	8.953E-08	0.825	618	1477

## CALCULATED THERMOELSETRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/K	2 1/K	27
i	500	-8.283E-01	1.834E+00	2,436E-02	3. 497E+02	7.451E-07	3.725E-04
2	500	-5.291E-01	2.243E+00	2.304E-02	3.527E+02	1.596E-06	9.577E-04
3	70 <b>0</b>	-3.154E-01	2.536E+00	2,186E-02	3.545E+02	2.781E-06	1.947E-03
4	800	-1.551E-01	2.755E+00	2.079E-02	3.557E+02	4.259E-06	3.407E-03
5	900	-5.884E-03	2.931E+00	1.782E-02	3.568E+02	6.336E-06	5.703E-03
6	1000	4.870E-02	3.045E+00	1.893E-02	3.583E+02	7.584E-06	7.584E-03
7	1190	9.337E-02	3.137E+00	1.812E-02	3.607E+02	8.902E-06	9.792E-03
8	1200	1.306E-01	3.215E+00	1.738E-02	3.647E+02	1.034E-05	1.240E-02
9	1300	1.621E-01	3.280E+00	1.670E-02	3.707E+02	1.195E-05	1.554E-02
10	1400	1.891E-01	3.336E+00	1.607E-02	3.793E+02	1.384E-05	1.938E-02

### NOTES

1) Thermal conductivity data was estimated.

COMPOSITION: (10.85.Mg0.15/CrQ3

SAMPLE #: AF 30

COMMENTS:

COEFFICIENTS TEMPERAT										
PROPERTY	STIME	A	9	3	D	Кs	MINIMUM	MAXIMUM		
log sigma	1/(che-ce)	1.190E+00	1.030E+03			0.998	618	1989		
		6.840E-01	4.936E+02			0.995	1089	1520		
log(s)gmaxK)	K/ (che-ce)	4.539E+00	1.380E+03			0.999	618	1089		
		4.22BE+00	1.049E+03			0.999	1089	1520		
lambda	#/ (a-K)	2.927E-01	2.355E-04							
S	uV/K	3.562E+02	-1.750E-01	1.450E-04	-2.968E-08	0.380	600	1461		

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	logisigmaxK) K/(ohm-cm)	lambda W/cm-K	a∧\k S	7 1/K	21
					*		
1	500	-8.708E-01	1.779E+00	2.436E-02	3.013E+02	5.017E-07	2.508E-04
2	500	-5.273E-01	2.239E+00	2.304E-02	2.970E+02	1.137E-06	6.822E-04
3	700	-2.820E-01	2.567E+00	2.186E-02	2.946E+02	2.07 <b>5E-06</b>	1.452E-03
4	800	-9.799E-02	2.814E+90	2.079E-02	2.938E+02	3.315E-06	2.a52E-03
5	900	4.512E-02	3.005E+00	1.992E-02	2.946E+02	4.858E-06	4.372E-03
5	1000	1.904E-01	3.179E+00	1.893E-02	2.966E+02	7.202E-06	7.202E-03
7	1190	2.353E-01	3.275E+00	1.812E-02	2.997E+02	3.519E-06	9.371E-03
8	1200	2.727E-01	3.354E+00	1.738E-92	3.038E+02	9.946E-06	1.193E-02
9	1300	3.043E-01	3.421E+00	1.670E-02	3.086E+02	1.149E-05	1.494E-02
10	1400	3.315E-01	3.479E+00	1.607E-02	3.140E+02	1.316E-05	1.843E-02
11	1500	3.550E-01	3.529E+00	1.548E-02	3.198E+02	1.496E-05	2.244E-02

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: (LaO.84,Sr0.16)Cr03

SAMPLE 4: AF_36

COMMENTS: agf. by General Refractories

COEFFICIENTS TEMPERAT										
PROPERTY	UNITS	A	B	C	D	R2	HINIHUM	MUMIKAM		
********		**********		***********		****				
log sigma	1/(oha-ca)	1.067E+00	1.321E+03			0.999	651	1173		
		1.994E+00	2.419E+03			0.996	1173	1548		
log(sig <b>ea</b> xK)	K/(oha-ca)	4.508E+00	1.744E+03			0.994	651	1548		
lambda	W/(m-K)	2.927E-01	2.355E-04							
S	uV/K	1.772E+02	4.000E-03	-3.984E-06	9.900E-09	0.943	606	1449		

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/K	7 1/K	21
1	600	-1.135E+00	1.601E+00	2.304E-02	1.803E+02	1.033E-07	6.196E-05
2	700	-8.208E-01	2.016E+00	2.186E-02	1.814E+02	2.275E-07	1.593E-04
3	800	-5.849E-01	2.328E+00	2.079E-02	1.829E+02	4.186E-07	3.349E-04
4	900	-4.013E-01	2.570E+00	1.982E-02	1.848E+02	6.839E-07	6.155E-04
5	1000	-2.545E-01	2.764E+00	1.893E-02	1.871E+02	1.029E-06	1.029E-03
6	1100	-2.054E-01	2.922E+00	1.812E-02	1.899E+02	1.241E-06	1.365E-03
7	1200	-2.20 <b>9E-</b> 02	3.055E+00	1.738E-02	1.934E+02	2.044E-06	2.453E-03
8	1300	1.330E-01	3.166E+00	1.670E-02	1.974E+02	3.170E-06	4.121E-03

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: (La0.84,Sr0.16)(A10.15,Cr0.85)03

SAMPLE #: AF_38

COMMENTS: mfg. by General Refractories

	COEFFICIENTS TEMPERATURE, K										
PROPERTY	UNITS	A	B	C	D	Кs	HUHINIH	MAXIMUM			
		********			**	*****					
log sigma	1/(ohm-cm)	1.020E+00	1.212E+03			0.996	637	1280			
		2.644E+00	3.264E+03			0.972	1280	1515			
log(sigeaxK)	K/(ohs-cs)	4.411E+00	1.595E+03			0.995	537	1515			
lambda	W/ (m-K)	2.927E-01	2.355E-04								
S	uV/K	1.284E+02	1.120E-01	-1.207E-04	5.454E-08	0.977	612	1459			

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log sigma	log(sigmaxK)	l a <b>e</b> bda	S	1	ZT
	K	1/(oha-ca)	K/(oha-ca)	. W/cm-K	uV/K	1/K	
1	500	-1.404E+00	1.222E+00	2.436E-02	1.611E+02	4.196E-08	2.098E-05
2	600	-1.000E+00	1.753E+00	2.304E-02	1.639E+02	1.166E-07	6.994E-05
3	700	-7.117E-01	2.133E+00	2.186E-02	1.664E+02	2.460E-07	1.722E-04
4	800	-4.952E-01	2.418E+00	2.079E-02	1.687E+02	4.377E-07	3.502E-04
5	900	-3.269E-01	2.639E+00	1.982E-02	1.7126+02	6.969E-07	5.272E-04
6	1000	-1.922E-01	2.816E+00	1.893E-02	1.743E+02	1.030E-06	1.030E-03
7	1100	-8.198E-02	2.961E+00	1.812E-02	1.782E+02	1.450E-06	1.595E-03
8	1290	-7.623E-02	3.082E+00	1.738E-02	1.832E+02	1.621E-06	1.945E-03
9	1300	1.330E-01	3.184E+00	1.570E-02	1.899E+02	2.932E-06	3.812E-03
10	1400	3.124E-01	3.272E+00	1.607E-02	1.983E+02	5.024E-06	7.034E-03

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: (La0.9,Ca0.1) (A10.15,Cr0.85)83

SAMPLE 4: AF_39

COMMENTS: ofg. by A-T Research

COEFFICIENTS TEMPERATURE.										
PROPERTY	UNITS	Α	8	C	D	Ŗ2	HINIHUH	MAXIMUM		
log sigma	1/(ohe-ca)	1.376E+00	2.473E+02		**	0.993	666	1094		
		1.222E+00	8.217E+01	****		0.917	1094	1517		
log(sigmaxK)	K/(ohe-ce)	4.753E+00	6.211E+02	****		0 <b>.999</b>	566	1517		
Lambda	W/(m-K)	2.927E-01	2.355E-04							
S	uV/K	1.282E+02	2.200E-01	-2.304E-04	8.783E-08	0.900	641	1421		

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/ce-K	S uV/K	7 1/K	ΣŤ
1	600	9.639E-01	3.718E+00	2.304E-02	1.962E+02	1.537E-05	9.224E-03
2	700	1.023E+00	3.866E+00	2.186E-02	1.994E+02	1.917E-05	1.342E-02
3	800	1.067E+00	3.977E+00	2.079E-02	2.017E+02	2.283E-05	1.826E-02
4	900	1.101E+00	4.063E+00	1.982E-02	2.036E+02	2.641E-05	2.376E-02
5	1000	1.140E+00	4.132E+00	1.893E-02	2.056E+02	3.081E-05	3.081E-02
6	1100	1.147E+00	4.188E+00	1.812E-02	2.083E+02	3.360E-05	3.696E-02
7	1200	1.154E+00	4.235E+00	1.738E-02	2.122E+02	3.688E-05	4.425E-02
8	1300	1.159E+00	4.275E+00	1.670E-02	2.178E+02	4.093E-05	5.321E-02

¹⁾ Thermal conductivity data was estimated.

ECHPOSITION: La(Mg0.02,A10.15,Cr0.83)03

SAMPLE #: AF_40

COMMENTS: mfg. by General Refractories

COEFFICIENTS TEMPERATE										
PROPERTY	UNITS	A	8	C	D	R2	MINIMUM	MUMIXAM		
				**						
log sigma	1/(ohe-ce)	4.110E-01	4.080E+02			0.997	661	1092		
		2.640E-01	2.506E+02			0.987	1092	1521		
log(sigmaxK)	K/(ohe-ce)	3.791E+00	7.840E+02			0.999	661	1521		
lambda	W/(m-K)	2.927E-01	2.355E-04							
S	uV/K	8.501E+01	1.274E+00	-1.655E-03	6.442E-07	0.681	601	1437		

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	\$ uV/K	1 1/K	21
1	600	-2.690E-01	2.484E+00	2.304E-02	3.928E+02	3.603E-06	2.162E-03
2	700	-1.719E-01	2.671E+00	2.186E-02	3.868E+02	4.609E-06	3.226E-03
3	800	-9.901E-02	2.811E+00	2.079E-02	3.748E+02	5.382E-06	4.305E-93
4	900	-4.234E-02	2.920E+00	1.982E-02	3.607E+02	5.955E-06	5.360E-03
5	1000	1.343E-02	3.007E+00	1.893E-02	3.482E+02	6.606E-06	6.606E-03
ь	1100	3.621E-02	3.079E+00	1.812E-02	3.413E+02	6.985E-06	7.684E-03
7	1200	5.519E-02	3.138E+00	1.738E-02	3.438E+02	7.721E-06	9.265E-03
8	1300	7.126E-02	3.188E+00	1.670E-02	3.596E+02	9.123E-06	1.186E-02

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: La(Mg0.02,A10.15,Cr0.83)03

SAMPLE #: AF_41

COMMENTS: mfg. by A-T Research

	COEFFICIENTS TEMPERATURE, K										
PROPERTY	UNITS	A	В	С	D	R2	MINIMUM	MAX I MUM			
*********				***********	**********						
log sigma	1/(ohm-cm)	8.020E-01	3.905E+02			0.794	632	1187			
		6.280E-01	1.956E+02		****	0.9 <b>99</b>	1186	1509			
log(sigmaxK)	K/(ohm-cm)	4.179E+00	7.612E+02			0.999	632	1509			
lambda	W/(m-K)	2.927E-01	2.355E-04								
S	uV/K	5.032E+02	-4.950E-01	4.619E-04	-1.327E-07	0.567	603	1385			

### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log sigma	log(sigmaxK)	l ambda	S	1	ZT
	K	1/(ohm-cm)	K/(ohe-ce)	W/ca-K	uV/K	1/K	
1	500	2.091E-02	2.657E+00	2.436E-02	3.546E+02	5.414E-06	2.707E-03
2	600	1.511E-01	2.910E+00	2.304E-02	3.438E+02	7.264E-06	4.358E-03
3	700	2.441E-01	3.092E+00	2.186E-02	3.375E+02	9.142E-06	6.399E-03
4	800	3.138E-01	3.227E+00	2.079E-02	3.348E+02	1.111E-05	8.889E-03
5	900	3.681E-01	3.333E+00	1.982E-02	3.351E+02	1.322E-05	1.190E-02
6	1000	4.115E-01	3.418E+00	1.893E-02	3.374E+02	1.550E-05	1.550E-02
7	1100	4.502E-01	3.487E+00	1.812E-02	3.409E+02	1.809E-05	1.9 <b>89</b> E-02
8	1200	4.650E-01	3.545E+00	1.738E-02	3.450E+02	1.998E-05	2.397E-02
9	1300	4.776E-01	3.593E+00	1.670E-02	3.487E+02	2.187E-05	2.843E-02

¹⁾ Thermal conductivity data was estimated.

EOMPOSITION: (La0.9,Ca0.1)(Al0.15,Cr0.95)03

SAMPLE #: AF_42

COMMENTS: afg. by General Refractories

COEFFICIENTS TEMPERATURE										
PROPERTY	UNITS	A	B	C	D	R≥	MINIMUM	MAXIMUM		
					*******		******			
log sigma	1/(ohm-cm)	1.301E+00	4.848E+02		***	0.994	581	1187		
		1.06BE+00	1.989E+02			0.934	1187	1507		
log(sigmaxK)	K/(ohs-cs)	4.672E+00	8.471E+02	••••		0.998	581	1507		
lambda	W/(m-K)	2.927E-01	2.355E-04		••••					
S	uV/K	1.424E+02	1.650E-01	-1.456E-04	5.239E-08	0.942	603	1324		

## CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/K	Z 1/K	<u></u>
1	500	3.315E-01	2.978E+00	2.436E-02	1.950E+02	3.348E-06	1.674E-03
2	600	4.931E-01	3.260E+00	2.304E-02	2.003E+02	5.416E-06	3.250E-03
3	700	6.085E-01	3.462E+00	2.186E-02	2.045E+02	7.766E-06	5.436E-03
4	800	6.951E-01	3.613E+00	2.079E-02	2.080E+02	1.031E-05	9.250E-03
5	900	7.624E-01	3.731E+00	1.982E-02	2.111E+02	1.301E-05	1.171E-02
6	1000	8.162E-01	3.825E+00	1.893E-02	2.141E+02	1.587E-05	1.587E-02
7	1100	8.872E-01	3.902E+00	1.812E-02	2.174E+02	2.011E-05	2.213E-02
8	1200	9.023E-01	3.966E+00	1.738E-02	2.212E+02	2.248E-05	2.698E-02
9	1300	9.150E-01	4.020E+00	1.670E-02	2.259E+02	2.513E-05	3.266E-02

¹⁾ Thermal conductivity data was estimated.

COMPOSITION: 30m/oPr02,70m/oZr32

SAMPLE #: FCCP166

COMMENTS:

COEFFICIENTS TEMPERA										
PROPERTY	UNITS	A	B	C	D	Ŕ3	MUMINIM	MUNIXAM		
log sig <b>s</b> a	1/ (ohe-ca)	2.751E+00	5.443E+03			0.995	585	1555		
1 : W1	W. 13 - N N									
log(sigmaxK)	K/lonm-cm/						***			
lambda	w/(m-K)	5.000E-01								
S	gV/k	-1.305E+02	1.399E+00	-1.051E-03	2.439E-07	0.425	815	1383		

### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm=K	5 u4/K	Z 1/K	ĮŢ
1	700	-5.025E+00	-2.180E+00	2.000E-02	4.175E+02	8.227E-11	5.759E-08
2	600	-4.053E+00	-1.150E+00	2.000E-02	4.410E+02	8.605E-10	6.884E-07
3	900	-3.297E+00	-3.429E-01	2.900E-92	4.551E+02	5.2268-09	4.704E-06
4	1500	-2.592E+00	J.077E-01	2.000E-02	4.615E+02	2.16JE-08	2.163E-05
5	1100	-2.197E+00	8.440E-01	2.000E-02	4.614E+02	6.755E-08	7.431E-05
6	1200	-1.785E+00	1.294E+00	2.000E-02	4.564E+02	1.708E-07	2.050E-04
7	1700	-1.436E+00	1.578E+00	2.000E-62	4.479E+02	3.6758-07	4.777E-04
ક	1406	-1.137E+00	2.009E+00	2.00 <b>0E</b> -02	4.375E+02	6.979E-07	9.770E-04

¹⁾ log(sigmaxK) was calculated from log sigma and temperature calculated data.

²⁾ Thermal conductivity data was estimated.

TIMPOSITION: SavoinICO, IP. ParoArG2.51.1avoIrO2

SAMPLE 4: FCCP54

COMMENTS:

COEFFICIENTS TEMFERATURE									
PROFERTY	dNITS	A	8	C	D	ñ2	MINIMUM	MUM I FAM	
log sigma	1//ohm-cm)	6.540E-01	3.0 <b>66E</b> +03			0.997	510	1547	
log(sigmaxk)	K/(ohm=cm)						***		
l aebda	#/ (#-K)	5.00vE-91					*	****	
S	2V 'k	3.1 <b>54E</b> +93	-7.023E+00	5.917E-03	-1.654E-06	0.384	1136	1419	

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	100 S1088	log(sigmaxK)	lambda	S	I	21
	ĸ	1/:ona-ca)	F/(ohm-cm)	<b>ボ/で第一年</b>	u¥7K	1/k	
1	1900	-2.3728+00	5.295E-01	2.000€-02	4.041E+02	3.471E-08	3.471E-05
- 2	1100	-2.093E+00	9.486E-01	2.0008-02	3.969E+02	6.361E-98	5.997E-05
7	1200	-1.861E+00	1.219E+00	2.000 <b>E</b> -02	3.989E+02	1.097E-07	1.315E-04
4	1700	-1.664E+00	1.450E+00	2.000E-02	4.001E+02	1.735E-07	2.255E-04
5	1400	-1.498E+00	1.a50E+00	2.000E-02	3.907E+02	2.437E-07	3.412E-04

#### YETES

^{1:} logistomaxi: was calculated from log sigma and temperature calculated data.

²⁾ Therma: conductivity data was estimated.

| 33MF9S1710N: | 75m/oln293.25m/oZr92

SAMPLE #: FCCP144

COMMENTS:

CDEFF1CIENTS TEMPERATURE, «										
PROPERTY	UNITS	A	В	C	D	ës.	MINIMUM	MAXIMUM		
					*********	*****				
log sigma	1/(ohe-ce)	2.260E+90	9.843E+01			0.950	563	1079		
		3.513E+00	1.449E+03			0.977	1079	1542		
log(sigmaxK)	K/(ohm-cm)		****							
l a <b>e</b> bda	₩/( <b>a-</b> K)	5.000E-01								
S	uV/K	1.830É+02	-6.320E-01	4.288E-04	-8.750E-08	0.881	932	1428		

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxk) K/(ohm-cm)	lambda W/cm-K	S uY/K	Z 1/K	21
!	800	2.137E+00	5.040E+00	2.000E-02	-7.304E+01	5.933E-05	4.746E-02
2	900	2.151E+00	5.105E+00	2.000E-02	-1.024E+02	7.410E-05	6.569E-02
3	1000	2.054E+00	5.064E+00	2.000E-02	-1.078E+02	6.730E-05	6.730E-02
4	1100	2.195E+00	5.237E+00	2.000E-02	-1.100E+02	9.483E-05	1.043E-01
5	1200	2.305E+00	5.384E+00	2.000E-02	-1.093E+02	1.207E-04	1.448E-01
0	1200	2.398E+00	5.512E+00	2.000E-02	-1.064E+02	1.416E-04	1.841E-01
7	1400	2.473E+00	5.624E+00	2.000E-02	-1.017E+02	1.555E-04	2.177E-01

¹⁾ log(sigmaxK) was calculated from log sigma and temperature calculated data.

²⁾ Thermal conductivity data was estimated.

[3#F351713N: 18.2m pin293.58.7m/pfr62.23.1m/d2r02

SAMPLE 4: FEEP160

COMMENTS:

	TEMPERATURE, K							
PROPERTY	UNITS	A	8	. C	ō	85	MINIMUM	HAXIMUM
log sigma	i/conm-cm)	-1.330E-01	2.562E+03			0.998	552	1390
		2.076E+00	5.574E+03			0.997	1390	1537
log(sigmaxK)	K/(ohe-ce)							
iambda	#/ (m-K)	5.000E-01						
S	uV/K	5.363E+01	-3.190E-01	1.733E-04	-2.193E-08	0.992	577	1393

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log sigma	logisigmaxk)	lambda	S	Z	ZT
	K	1/(one-cm)	K/(ohm-cm)	W/cs-K	uV/K	1/K	
	500	-5.258E+00	-2.559E+00	2.000E-02	-6.528E+01	1.177E-12	5.885E-10
1							
2	50 <b>0</b>	-4.404E+00	-1.626E+00	2.000E-02	-8.012E+01	1.267E-11	7.602E-09
3	700	-3.79 <b>4E+</b> 00	-9.485E-01	2.000E-92	-9.227E+01	6.848E-11	4.793E-08
4	800	-3.33 <b>6E+</b> 00	-4.329E-01	2.000E-02	-1.019E+02	2.394E-10	1.915E-07
5	700	-2.780E+00	-2.587E-02	2.900E-02	-1.091E+02	6.228E-10	5.605E-07
b	1000	-2.695E+00	3.046E-01	2.000E-02	-1.140E+02	1.310E-09	1.310E-06
7	1100	-2.462E+00	5.789E-01	2.000E-02	-1.168E+02	2.350E-09	2.585E-06
8	1200	-2.2 <b>68E+</b> 00	8.108E-01	2.000E-02	-1.175E+02	3.722E-09	4.467E-06
Ģ	1200	-2.211E+00	7.026E-01	2.000E-02	-1.164E+02	4.162E-09	5.410E-06
10	1400	-1.905E+00	1.241E+00	2.000E-02	-1.135E+02	8.010E-09	1.121E-05

#### NÜTES

¹⁾ log(sigmaxK) was calculated from log sigma and temperature calculated data.

²⁾ Thermal conductivity data was estimated.

COMPOSITION: 20.1m/oln203.39.um/oPr02.40.2m/olr02

SAMPLE #: FCCP93

COMMENTS:

	TEMPERA	TEMPERATURE, K						
PROPERTY	UNITS	Α	В	C	0	Ϋ́S	MINIMUM	HAXIHUH
log sigma	1 ( ( sheers)	-2.380E-01	4,483E+02		-7	0.999	551	883
toň siåme	17 tolle-ca/	2.5258+00	2.489E+03			0.981	983	1547
log(sigmaxK)	K/(ohe-ce)		*					
lasbda	al/ (m~K)	5.000E-01						
2	uV/K	8.390E+01	-4.888E-01	3.790E-04	-9.207E-08	0.969	535	1377

## CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/k	7 1/K	21
i	500	-1.133 <b>E</b> +00	1.566E+00	2.000 <b>E</b> -02	-7.726E+01	2.199E-08	1.100E-0 <b>5</b>
2	600	-9.831E-01	1.795E+00	2.00 <b>0E</b> -02	-9.283E+01	4.479E-08	2.487E-05
3	700	-8.764E-01	1.9698+00	2.000E-02	-1.041E+92	7.206E-08	5.045E-05
#	800	-8.357E-01	2.067E+00	2.000E-02	-1.117E+02	9.111E-08	7.289E-05
5	990	-4.523E-01	2.492E+00	2.000E-02	-1.161E+02	2.327E-07	2.094E-04
۵	1990	-1.535E-01	2.836E+00	2.00 <b>0E</b> -02	-1.180E+02	4.775E-07	4.775E-04
7	1100	8.088E-02	3.122E+00	2.000E-02	-1.177E+92	8.350E-07	9.185E-94
ŝ	1200	2.846E-01	3.364E+00	2.000E-02	-1.160E+02	1.295E-06	1.555E-03
9	1300	4.569E-01	3.571E+00	2.000E-02	-1.133E+92	1.838E-06	2.390E-03
10	1400	5.046E-01	3.751E+00	2.0008-02	-1.102E+92	2.444E-06	3.422E-03

¹⁾ log(sigmaxK) was calculated from log sigma and temperature calculated data.

²⁾ Thermal conductivity data was estimated.

| ISMPOSITION: 23m/sin203.34.3m/sPr02.42.7m/s2r02

SAMPLE #: FCCP52

COMMENTS:

COEFFICIENTS TE										
PROPERTY	UNITS	A	B	C	0	Ŗ2	HINIHUH	MAXIMUM		
log sigma	1/(ohm-cm)	1.220E+00	1.411E+03			0.970	566	817		
		2.691E+00	2.582E+03			0.997	917	1556		
logisigmaxK)	K/(cha-ca)									
lambda	W/ (a-k)	5.000E-01								
S	u∀/K	2.184E+01	-2.311E-01	1.010E-04	-4.301E-09	0.988	556	1378		

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log signa	log(sigmaxK)	lambda	S	1	21
	<u>K</u>	1//ohe-ce)	K/(ohe-ce)	M/ca-K	uV/X	1/K	
1	500	-1.603E+00	1.096E+00	2.000E-02	-6.899E+01	5.940E-09	2.970E-06
2	600	-1.132E+00	1.646E+00	2.000E-02	-8.139E+01	2.442E-08	1.465E-05
3	700	-9.974E-01	1.848E+00	2.000E-02	-9.191E+01	4.249E-08	2.974E-05
4	800	-5.364E-01	2.367E+00	2.000E-02	-1.006E+02	1.472E-07	1.177E-04
5	900	-1.77 <b>9E-</b> 01	2.776E+00	2.000E-02	-1.075E+02	3.835E-07	3.452E-04
5	1000	1.091E-01	3.109E+00	2.000E-02	-1.126E+02	8.143E-07	8.143E-04
7	1100	3.438E-01	3.385E+00	2.000E-02	-1.159E+02	1.482E-06	1.630E-03
3	1200	5.394E-01	3.619E+00	2.000E-02	-1.175E+02	2.389E-06	2.867E-03
9	1300	7.049E-01	3.819E+00	2.000E-02	-1.173E+02	3.490E-06	4.537E-03
10	1400	9.4686-01	3.993E+00	2.000E-02	-1.155E+02	4.690E-06	6.566E-03

¹⁾ log(sigmax#) was calculated from log sigma and temperature calculated data.

²⁾ Thermal conductivity data was estimated.

COMPOSITION: 36.6m/pln203.28.6m/pPr02.34.8m/oZr02

SAMPLE 4: FCCP51

COMMENTS:

		TEMPERATURE, K						
PROPERTY	UNITS	A	В	C	D	Ķ2	HINIHUM	MUNIXAM
					*********		******	
log sigma	1/(ohe-ce)	1.911E+00	8.635E+02			0.978	539	766
•		3.465E+00	2.045E+03		****	0.994	766	1565
log(sig <b>e</b> axK)	) K7 (ohe-ce)							
lambda	d/ (a-K)	5.000E-01		****				
S	uV/K	7.600E+00	-1.640E-01	-1.254E-05	5.291E-08	0.992	484	1221

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log sigma	log(sig <b>s</b> axK)	lambda	S	Z	ZT
	ĸ	1/(ohe-cm)	K/(ohm-cm)	W/cm-K	uV/K	1/K	
1	500	1.841E-01	2.883E+00	2.000E-02	-7.092E+01	3.842E-07	1.921E-04
2	500	4.719E-01	3.250E+00	2.000E-02	-8.389E+01	1.043E-06	6.257E-04
3	700	5.150E-01	3.360E+00	2.000E-02	-9.520E+01	1.483E-06	1.038E-03
4	300	8.838E-01	3.787E+00	2.000E-92	-1.045E+02	4.181E-06	3.345E-03
5	900	1.171E+00	4.125E+00	2.000E-02	-1.116E+02	9.221E-06	8.299E-03
6	1000	1.400E+00	4.400E+00	2.000E-02	-1.160E+02	1.691E-05	1.691E-02
7	1100	1.588E+00	4.629E+00	2.000E-02	-1.176E+02	2.674E-95	2.941E-02
3	1200	1.744E+00	4.823E+00	2.000E-02	-1.158E+02	3.722E-05	4.467E-02

i) log(sigmaxK) was calculated from log sigma and temperature calculated data.

²¹ Thermal conductivity data was estimated.

COMPOSITION: 11.2m/oIn203.88.8m/oSn02

SAMPLE #: FC_56

COMMENTS:

COEFFICIENTS T										
PROPERTY	UNITS	A	В	3	D	R2	MINIMUM	MAXIMUM		
				*********			*****			
log sigma	1/(ohm-cm)	1.476E+00	8.231E+02			0.980	613	1111		
1/-:	W//-b>									
log(sigmaxK)	K/ (ORBTER)									
lambda	W/(m-K)	4.249E-02	2.503E-04			0.910	563	1101		
S	uV/K	5.899E+01	-2.277E-01	9.73 <b>8E</b> -05	-2.292E-09	0.986	601	1335		

### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/K	7 1/K	21
1	500	-1.702E-01	2.529E+00	5.964E-02	-3.081E+01	1.075E-08	5.376E-06
2	600	1.042E-01	2.882E+00	5.190E-02	-4.307E+01	4.544E-08	2.727E-05
3	700	3.001E-01	3.145E+00	4.593E-02	-5.348E+01	1.243E-07	8.700E-05
4	800	4.471E-01	3.350E+00	4.119E-02	-6.203E+01	2.615E-07	2.092E-04
5	900	5.614E-01	3.516E+00	3.734E-02	-6.875E+01	4.610E-07	4.149E-04
6	1000	6.529E-01	3.653E+00	3.415E-02	-7.364E+01	7.140E-07	7.140E-04
7	1100	7.277E-01	3.769E+00	3.146E-02	-7.572E+01	9.994E-07	1.099E-03

¹⁾ log(sigmaxK) was calculated from log sigma and temperature calculated data.

COMPOSITION: 16.3m/oIn203,83.6m/oSn02

SAMPLE #: FC_57

COMMENTS:

	COEFFICIENTS TEMPERATURE, K										
PROPERTY	UNITS	A	В	C	D	8 ₅	HINIMUM	MAXIMUM			
log sigma	1/(ohe-cm)	1.409E+00	1.155E+03			0.999	606	961			
log(sigmaxK)	K/(one-ce)	****									
lambda	W/ (m-K)	1.943E-01	1.982E-04			0.720	618	1088			
S	цV/K	-9.807E+00	-2.660E-02	-9.322E-05	5.899E-08	0.994	607	1312			
J	MIT/IN	/ : UV/ L : VV	2.000F 05	/. JTTF //	3.0175-70	V: 177	97/	1312			

### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(dhm-cm)	lambda W/cm-K	S u∀/K	7 1/K	21
1	500	-9.010E-01	1.798E+00	3.408E-02	-3.904E+01	5.616E-09	2.808E-06
2	500	-5.160E-01	2.262E+00	3.193E-02	-4.659E+01	2.072E-08	1.243E-05
3	700	-2.410E-01	2.604E+00	3.003E-02	-5.387E+01	5.549E-08	3.884E-05
4	800	-3.475E-02	2.868E+00	2.834E-02	-6.055E+01	1.194E-07	9.552E-05
5	900	1.257E-01	3.080E+00	2.683E-02	-6.625E+01	2.185E-07	1.966E-04
6	1000	2.540E-01	3.254E+00	2.548E-02	-7.064E+01	3.515E-07	3.515E-04

¹⁾ log(sigmaxK) was calculated from log sigma and temperature calculated data.

COMPOSITION: 30.6m/oin203.69.45n02

SAMPLE #: FC_59

COMMENTS:

	COEFFICIENTS TEMPERATURE, K										
PROPERTY	UNITS	A	В	C	D	K3	MINIMUM	MAXIMUM			
**********					-+						
log sigma	1/(ohm-cm)	2.142E+00	-2.715E+02			0.980	1331	1731			
		2.751E+00	8.670E+02			0.940	708	1148			
log(sigmaxK)	K/(ohe-ca)										
lambda	W/ (m-K)	1.943E-01	1.982E-04								
S	uV/K	-1.930E+01	1.552E-02	-1.104E-04	5.332E-08	0.998	609	1333			

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(dhm-cm)	lambda W/cm-K	S uV/K	2 1/K	21
1	500	1.306E+00	4.084E+00	3.193E-02	-3.921E+01	9.254E-07	5.552E-04
2	79 <b>0</b>	1.512E+00	4.35BE+00	3.003E-02	-4.424E+01	2.121E-06	1.485E-03
3	800	1.667E+00	4.570E+00	2.834E-02	-5.024E+01	4.140E-06	3.312E-03
4	900	1.788E+00	4.742E+00	2.683E-02	-5.589E+01	7.138E-06	6.425E-03
5	1000	1.884E+00	4.884E+00	2.548E-02	-6.086E+01	1.113E-05	1.113E-02
6	1100	1.963E+00	5.004E+00	2.425E-02	-6.484E+01	1.591E-05	1.751E-02
7	1200	2.368E+00	5.447E+00	2.314E-02	-6.752E+01	4.599E-05	5.519E-02
8	1300	2.351E+00	5.465E+00	2.213E-02	-6.956E+01	4.765E-05	6.194E-02

¹⁾ log(sigmaxK) was calculated from log sigma and temperature calculated data.

²⁾ Thermal conductivity data was estimated.

COMPOSITION: 40m/oln203,60m/oSn02

SAMPLE #: FC_125

COMMENTS:

			COEFF1C	IENTS			TEMPERA	TURE, K
PROPERTY	UNITS	A	В	C	D	Кs	MINIMUM	MAXIMUM
				*-*			*****	
log sigma	1/(ohe-ce)	2.581E+00	3.586E+02			0.990	663	1517
11-:	W//-b>							
log(sig <b>ma</b> xK)	K/(ONE-CE)			+				
l a <b>n</b> bda	W/(m-K)	1.943E-01	1.982E-04					
S	aV/K	3.304E+01	-2.150E-01	9.859E-05	-1.698E-08	0.990	503	1343

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log sigma	log(sigmaxK)	lambda	\$	1	21
	K	1/(ohe-ce)	K/(ohe-ce)	W/ca-K	uV/K	1/K	
1	600	1.983E+00	4.761E+00	3.193E-02	-6.416E+01	1.241E-05	7.446E-03
2	700	2.069E+00	4.914E+00	3.003E-02	-7.501E+01	2.195E-05	1.537E-02
3	800	2.133E+00	5.036E+00	2.834E-02	-8.460E+01	3.428E-05	2.743E-02
4	900	2.183E+00	5.137E+00	2.683E-02	-9.303E+01	4.910E-05	4.419E-02
5	1000	2.22E+00	5.222E+00	2.548E-02	-1.004E+02	6.603E-05	6.603E-02
6	1100	2.255E+00	5.296E+00	2.425E-02	-1.068E+02	8.464E-05	9.310E-02
7	1200	2.282E+00	5.361E+00	2.314E-02	-1.124E+02	1.045E-04	1.255E-01
8	1300	2.305E+00	5.419E+00	2.213E-02	-1.172E+02	1.254E-04	1.630E-01

¹⁾ log(sigmaxK) was calculated from log sigma and temperature calculated data.

²⁾ Thermal conductivity data was estimated.

COMPOSITION: 50m/bln203,50m/oSn02

SAMPLE #: FC_97_7

COMMENTS:

	COEFFICIENTS TEMPERATURE, K										
PROPERTY	UNITS	A	B	C	B	Кs	HUHIHIH	MAXIMUM			
log sigma	1/tohm-cm)	2.457E+00	2.156E+00			9.900	711	1676			
log(sigmaxK)	K/(ohm-cm)	***									
l ambda	W/{m-K}	1.943E-01	1.982E-04								
S	uV/K	-7.295E+00	-8.054E-02	-2.971E-05	2.801E-08	0.999	471	1341			

### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/K	<i>I</i> 1/K	<u> </u>
1	600	2.453E+00	5.232E+00	3.193E-02	-6.026E+01	3.231E-05	1.939E-02
2	700	2.454E+00	5.299E+00	3.003E-02	-6.862E+01	4.460E-05	3.122E-02
3	800	2.454E+00	5.357E+00	2.834E-02	-7.639E+01	5.862E-05	4.689E-02
4	900	2.455E+00	5.409E+00	2.683E-02	-8.342E+01	7.387E-05	6.648E-02
5	1000	2.455E+00	5.455E+00	2.548E-02	-8.953E+01	8.966E-05	8.966E-02
6	1100	2.455E+00	5.496E+00	2.425E-02	-9.455E+01	1.051E-04	1.156E-01
7	1200	2.455£+00	5.534E+00	2.314E-02	-9.331E+01	1.191E-04	1.430E-01
3	1300	2.455E+00	5.569E+00	2.213E-02	-1.007E+02	1.307E-04	1.698E-01

¹⁾ log(sigmaxK) was calculated from log sigma and temperature calculated data.

²⁾ Thermal conductivity data was estimated.

||CMPGS1716N: 60m/pin203,40m/p5n02

SAMPLE #: FO_126

COMMENTS:

	TEMPERA	TEMPERATURE, <						
PROPERTY	UNITS	A	8	C	D	Ąz	MINIMUM	MAXIMUM
iog sigma	1/(chm-cm)	3.054E+00	5.427E+02			0.980	1291	1575
		2.619E+00				0.000	525	1281
log (sigmaxk)	) K/(one-ce)							
lambda	W/(a-K)	1.943E-01	1.982E-04					
s	u¥rk	-7.422E+01	2.249E-01	-3.937E-04	1.a18E-07	0.995	613	1252

#### CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm/	lambda W/cm-K	S gV/K	Z 1/K	21
1	500	2.619E+00	5.318E+00	3.40BE-02	-3.797E+01	1.9508-05	9.748E-95
2	500	2.619E+00	5.397E+60	3.193E-02	-4.a06E+01	2.764E-05	1.558E-02
3	700	2.619E+00	5.464E+00	3.003E-02	-5.4218+91	4.070E-05	2.849E-02
4	800	2.a19E+00	5.522E+00	2.834E-01	-6.343E+01	5.9048-05	4.723E-02
5	200	2.519E+00	5.573E+00	2.483E-02	-7.275E+01	8.205E-05	7.384E-02
5	1000	2.519E+00	5.619E+00	2.548E-02	-8.122E+v1	1.077E-04	1.077E-01
7	1100	2.619E+00	5.560E+00	2.425E-02	-8.785E+01	1.7246-04	1.455E~01
÷	1	2.a19E+00	5.6986+00	2.314E-02	-9.1AS2+01	1.511E-04	1.813E-01
:	12(4)	2.a17E+00	5.733E+00	2.213E-02	-9.173E+01	1.582E-04	2.0 <b>56E</b> -01

### MOTES

[!] log(sigmax*) was calculated from log sigma and temperature calculated data.

²⁾ Thermal conductivity data was estimated.

COMPOSITION: 70m/oin2a3.30m/osn02

SAMPLE #: FC_97_9

COMMENTS:

COEFFICIENTS										
PROPERTY	UNITS	A B C D				R2	MINIMUM	HAXIMUM		
10g 51gma	i/(ohe-ce)	2.663E+00	-1.521E+02			0.850	597	1100		
- ,		3.291E+00	5.307E+02			0.960	1100	1541		
log(sigmaxK	K/(ohe-ce)			****						
lambda	a/ (a-K)	2.121E-01	1.239E-94			0.241	500	1291		
S	aV/K	7.346E+01	-3.028E-01	1.962E-04	-4.217E-08	0.994	610	1326		

## CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S W/K	1 1/K	ZT
1	500	2.967E+00	5.666E+00	3. <b>650E-02</b>	-3.416E+01	2.945E-05	1.482E-02
2	600	2.917E+00	5.695E+00	3.492E-02	-4.070E+01	5.153E-05	3.092E-02
3	700	2.880E+00	5.725E+00	3.3475-02	-5.683E+01	7.324E-05	5.126E-02
4	800	2.853E+00	5.756E+00	3.214E-02	-6.480E+01	9.317E-05	7.454E-02
5	900	2.832E+00	5.786E+00	3.091E-02	-7.088E+01	1.104E-04	9.936E-02
6	1900	2.760E+00	5.7608+00	2.977E-02	-7.531E+01	1.097E-04	1.0978-01
7	1199	2.809E+00	5.850E+00	2.871E-02	-7.835E+01	1.376E-04	1.513E-01
8	1200	2.849E+00	5.928E+00	2.772E-02	-8.024E+01	1.639E-04	1.9678-01
9	1300	2.883E+00	5.997E+00	2.680E-02	-8.125E+01	1.880E-04	2.444E-01

¹⁾ log(signaxK) was calculated from log signa and temperature calculated data.

COMPOSITION: 80m/oin203,20m/oSn02

SAMPLE #: FC_97_10

COMMENTS:

COEFFICIENTS								TEMPERATURE. K		
PROPERTY	UNITS	A	B	C	D	₩3	HINIHUM	MAXIMUM		
			*******							
log sigma	1/(ohm-cm)	3.040E+00	-7.582E+01			0.500	585	1578		
log(sigmaxK)	K//sha-ca)									
indisiâmevu.	K/ (VIIB-CE/									
laebda	W/(m-K)	1.842E-01	-9.460E-05			0.340	468	1098		
S	uV/K	-2.980E+01	3.315E-02	-7.049E-05	2.565E-08	0.997	479	1424		

## CALCULATED THERMOELECTRIC PROPERTIES

	Temperature	log sigma	log(sigmaxK)	lambda	S	1	ZT
	K	1/(ohs-cs)	K/(ohe-ce)	W/ca-K	uV/K	1/K	
1	500	3.192E+00	5.891E+00	7.304E-02	-2.764E+01	1.627E-05	8.133E-03
2	600	3.166E+00	5.945E+00	7.846E-02	-2.975E+01	1.654E-05	9.927E-03
3	700	3.148E+00	5.993E+00	8.475E-02	-3.234E+01	1.736E-05	1.215E-02
4	800	3.135E+00	6.038E+00	9.213E-02	-3.526E+01	1.841E-05	1.472E-02
5	900	3.124E+00	6.078E+00	1.009E-01	-3.836E+01	1.941E-05	1.747E-02
6	1000	3.116E+00	6.116E+00	1.116E-01	-4.149E+01	2.014E-05	2.014E-02
7	1100	3.109E+00	6.150E+00	1.248E-01	-4.448E+01	2.038E-05	2.242E-02

¹⁾ log(sigmaxK) was calculated from log sigma and temperature calculated data.

COMPOSITION: 90.2m/oin203,9.8m/oSn02

SAMPLE #: FC_160

COMMENTS:

CDEFFICIENTS							TEMPERA	TEMPERATURE, K		
PROPERTY	UNITS	A	В	C	<b>D</b> .	Ŗ≥	MINIMUM	MAXIMUM		
log sigma	1/(ohe-ce)	2.675E+00	-1.250E-02				***			
log(sigmaxK)	K/(ohe-ce)		***				***			
lambda	W/(m-K)	1.943E-01	1.982E-04			*****	***	***		
s	uV/K	-8.879E+01	2.549E-01	-3.777E-04	1.510E-07	0.998	607	1326		

## CALCULATED THERMOELECTRIC PROPERTIES

	Temperature K	log sigma 1/(ohm-cm)	log(sigmaxK) K/(ohm-cm)	lambda W/cm-K	S uV/K	7 1/K	21
1	600	2.675E+00	5.453E+00	3.193E-02	-3.920E+01	2.277E-05	1.366E-02
2	700	2.675E+00	5.520E+00	3.003E-02	-4.363E+01	3.00 <b>0E-</b> 05	2.100E-02
3	800	2.675E+00	5.578E+00	2.834E-02	-4.927E+01	4.054E-05	3.243E-02
4	900	2.675E+00	5.629E+00	2.683E-02	-5.522E+01	5.378E-05	4.840E-02
5	1990	2.675E+00	5.675E+00	2.548E-02	-6.057E+01	6.814E-05	6.814E-02
6	1100	2.675E+00	5.716E+00	2.425E-02	-6.441E+01	8.094E-05	B.904E-02
7	1200	2.675E+00	5.754E+90	2.314E-02	-6.584E+01	8.864E-05	1.064E-01
8	1300	2.675E+00	5.789E+00	2.213E-02	-6.395E+01	9.746E-05	1.137E-01

¹⁾ log(sigmaxK) was calculated from log sigma and temperature calculated data.

²⁾ Thermal conductivity data was estimated.

³⁾ Electrical conductivity was temperature independent.

